



NHS3100

NTAG SmartSensor temperature monitor

Rev. 8.03 — 27 May 2021

Product data sheet

1 General description

The NXP Semiconductors NHS3100 is a member of the NTAG SmartSensor product family. The IC is optimized for temperature monitoring and logging. It has an embedded NFC interface, an internal temperature sensor, and a direct battery connection. These features support an effective system solution with a minimal number of external components and a single layer foil implementation for temperature monitoring. The NHS3100 works either battery-powered or NFC-powered.

The embedded Arm Cortex-M0+ offers flexibility to the users of this IC to implement their own dedicated solution. The NHS3100 contains multiple features, including multiple power-down modes and a selectable CPU frequency of 8 MHz and down for ultra-low power consumption.

Users can program this NHS3100 with the industry-wide standard solutions for Arm Cortex-M0+ processors.

As of September 22, 2017, the NFC forum has certified this device (certification ID: 58516).

CAUTION



Semiconductors are light sensitive. Exposure to light sources can cause the IC to malfunction. The IC must be protected against light. The protection must be applied to all sides of the IC.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices. Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.



2 Features and benefits

2.1 System

- Arm Cortex-M0+ processor running at frequencies of up to 8 MHz
- Arm Cortex-M0+ built-in nested vectored interrupt controller (NVIC)
- Arm serial wire debug (SWD)
- System tick timer
- IC reset input

2.2 Memory

- 32 kB on-chip flash programming memory
- 4 kB on-chip EEPROM of which 320 bytes are write-protected
- 8 kB SRAM

2.3 Digital peripherals

- Up to 12 general-purpose I/O (GPIO) pins with configurable pull-up/pull-down resistors and repeater mode
- GPIO pins which can be used as edge and level sensitive interrupt sources
- High-current drivers (sink only; 20 mA) on four GPIO pins
- High-current drivers (sink only; 20 mA) on two I²C-bus pins
- Programmable watchdog timer (WDT)

2.4 Analog peripherals

- Temperature sensor with:
 - ± 0.5 °C absolute temperature accuracy between -40 °C and 0 °C
 - ± 0.3 °C absolute temperature accuracy between 0 °C and $+45$ °C
 - ± 0.5 °C absolute temperature accuracy between $+45$ °C and $+85$ °C

2.5 Communication interfaces

- NFC/RFID ISO 14443 type A interface; NFC Forum type 2 compatible
- I²C-bus interface supporting full I²C-bus specification and fast mode with a data rate of 400 kbit/s, with multiple-address recognition and monitor mode

2.6 Clock generation

- 8 MHz internal RC oscillator, trimmed to 2 %, accuracy, which is used for the system clock
- Timer oscillator operating at 32 kHz linked to an RTC timer unit

2.7 Power control

- Support for 1.72 V to 3.6 V external voltages
- The NHS3100 can also be powered from the NFC field.
- Activation via NFC possible
- Integrated power management unit (PMU) for versatile control of power consumption

- Four reduced power modes for Arm Cortex-M0+: sleep, deep-sleep, deep power-down, and battery-off
- Power gating for each analog peripheral for ultra-low power operation
- < 50 nA IC current consumption in battery-off mode at 3.0 V
- Power-on reset (POR)

2.8 General

- Unique device serial number for identification

3 Applications

- Temperature measurement
- Temperature logging
- Cold chain validation

4 Ordering information

Table 1. Ordering information

| Type number | Package | | Version |
|-------------|------------|--|-----------|
| | Name | Description | |
| NHS3100 | HVQFN24 | plastic thermal enhanced very thin quad flat package; no leads; 24 terminals; body 4 × 4 × 0.85 mm | SOT616-3 |
| NHS3100UK | WLCSP25 | wafer level chip-scale package; 25 balls; 2.51 × 2.51 × 0.5 mm | SOT1401-1 |
| NHS3100W8 | bumped die | bumped die with 8 functional bumps; 2.51 × 2.51 × 0.16 mm | SOT1870-1 |

5 Marking

Table 2. Marking codes

| Type number | Marking code |
|-------------|-----------------|
| NHS3100 | NHS3100 |
| NHS3100UK | NHS3100 |
| NHS3100W8 | no marking code |

6 Block diagram

Figure 1 shows the internal block diagram of the NHS3100. It includes a power management unit (PMU), clocks, timers, a digital computation, a control cluster (Arm Cortex-M0+ and memories), and AHB/APB slave modules.

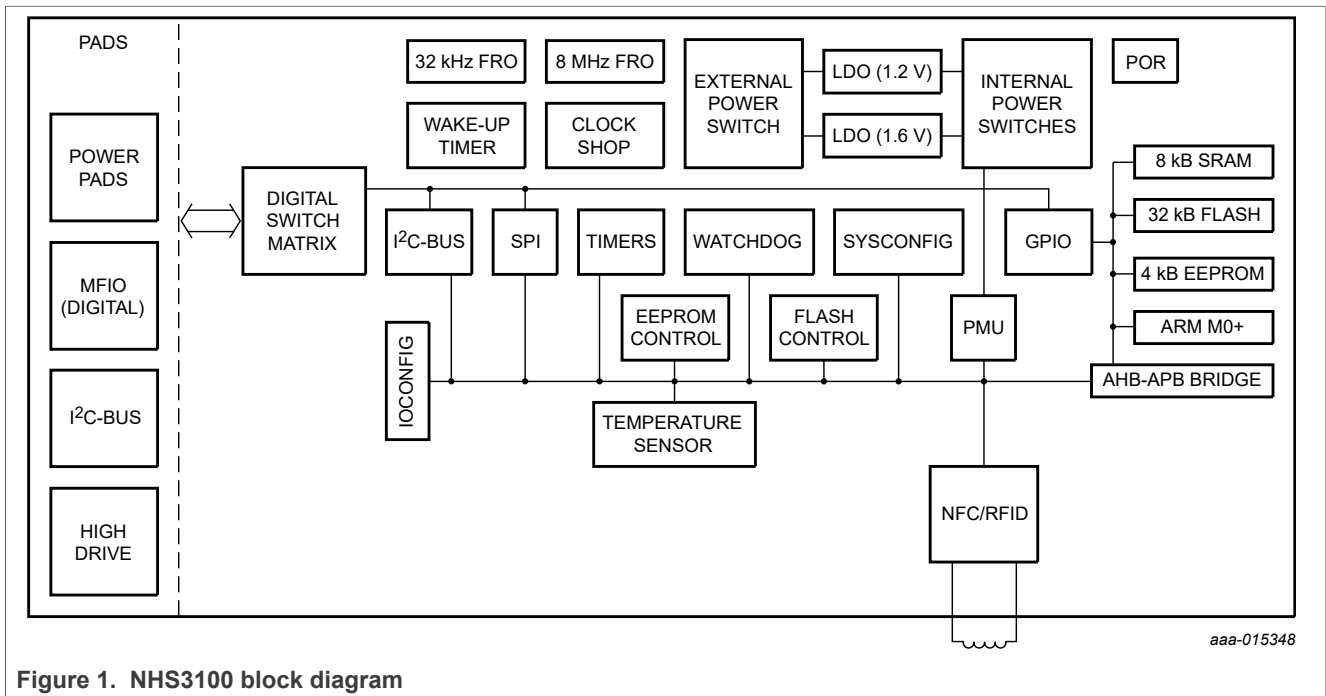


Figure 1. NHS3100 block diagram

7 Pinning

The pin functionality depends on the particular configuration of the chip and is application-dependent. Pin functions are software-assigned through the IOCON configuration registers. The sections below show the pinning of the packages.

7.1 HVQFN24

Figure 2 shows the pad layout of the NHS3100 in the HVQFN24 package.

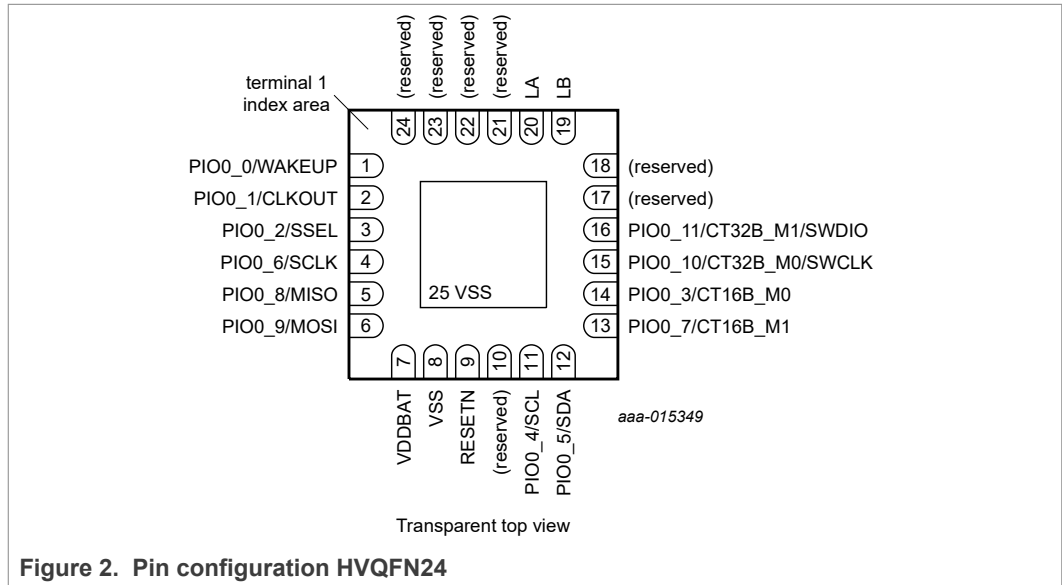


Table 3. Pad allocation table of the HVQFN24 package

| Pad | Symbol | Pad | Symbol |
|-----|---------------|-------------------|------------------------|
| 1 | PIO0_0/WAKEUP | 13 ^[1] | PIO0_7/CT16B_M1 |
| 2 | PIO0_1/CLKOUT | 14 ^[1] | PIO0_3/CT16B_M0 |
| 3 | PIO0_2/SSEL | 15 ^[1] | PIO0_10/CT32B_M0/SWCLK |
| 4 | PIO0_6/SCLK | 16 ^[1] | PIO0_11/CT32B_M1/SWDIO |
| 5 | PIO0_8/MISO | 17 ^[2] | (reserved) |
| 6 | PIO0_9/MOSI | 18 ^[2] | (reserved) |
| 7 | VDDBAT | 19 | LB |
| 8 | VSS | 20 | LA |
| 9 | RESETN | 21 ^[2] | (reserved) |
| 10 | (reserved) | 22 ^[2] | (reserved) |
| 11 | PIO0_4/SCL | 23 ^[2] | (reserved) |
| 12 | PIO0_5/SDA | 24 ^[2] | (reserved) |

[1] High source current pads. See [Section 8.6.3](#).
 [2] These pads must be tied to ground.

Table 4. Pad description of the HVQFN24 package

| Pad | Symbol | Type | Description |
|---------------------------|----------|--------|---|
| Supply | | | |
| 7 | VDDBAT | supply | positive supply voltage |
| 8 | VSS | supply | ground |
| GPIO^[1] | | | |
| 1 | PIO0_0 | I/O | GPIO |
| | WAKEUP | I | Deep power-down mode wake-up pin ^[2] |
| 2 | PIO0_1 | I/O | GPIO |
| | CLKOUT | O | clock output |
| 3 | PIO0_2 | I/O | GPIO |
| | SSEL | I | SPI/SSP serial select line |
| 14 | PIO0_3 | I/O | GPIO |
| | CT16B_M0 | O | 16-bit timer match output 0 |
| 11 | PIO0_4 | I/O | GPIO ^[3] |
| | SCL | I/O | I ² C SCL clock line |
| 12 | PIO0_5 | I/O | GPIO ^[3] |
| | SDA | I/O | I ² C SDA data line |
| 4 | PIO0_6 | I/O | GPIO |
| | SCLK | I/O | SPI/SSP serial clock line |
| 13 | PIO0_7 | I/O | GPIO |
| | CT16B_M1 | O | 16-bit timer match output 1 |
| 5 | PIO0_8 | I/O | GPIO |
| | MISO | O | SPI/SSP master-in slave-out line |
| 6 | PIO0_9 | I/O | GPIO |
| | MOSI | I | SPI/SSP master-out slave-in line |
| 15 | PIO0_10 | I/O | GPIO |
| | CT32B_M0 | O | 32-bit timer match output 0 |
| | SWCLK | I | Arm SWD clock |
| 16 | PIO0_11 | I/O | GPIO |
| | CT32B_M1 | O | 32-bit timer match output 1 |
| | SWDIO | I/O | Arm SWD I/O |
| Radio | | | |
| 20 | LA | A | NFC antenna/coil terminal A |
| 19 | LB | A | NFC antenna/coil terminal B |

Table 4. Pad description of the HVQFN24 package...continued

| Pad | Symbol | Type | Description |
|--------------|--------|------|-------------------------------------|
| Reset | | | |
| 9 | RESETN | I | external reset input ^[4] |

- [1] The GPIO port is a 12-bit I/O port with individual direction and function controls for each bit. The operation of port 0 pads depends on the function selected through the IOCONFIG register block.
- [2] If external wake-up is enabled on this pin, it must be pulled HIGH before entering deep power-down mode. To exit deep power-down mode, it must be pulled LOW for a minimum of 100 μs.
- [3] Open drain, no pull-up or pull down.
- [4] A LOW on this pad resets the device. This reset causes I/O ports and peripherals to take on their default states, and processor execution to begin at address 0. It has weak pull-up to V_{BAT} or internal NFC voltage (whichever is highest).

7.2 WLCSP25

Figure 3 shows the ball layout of the NHS3100 in the WLCSP25 package.

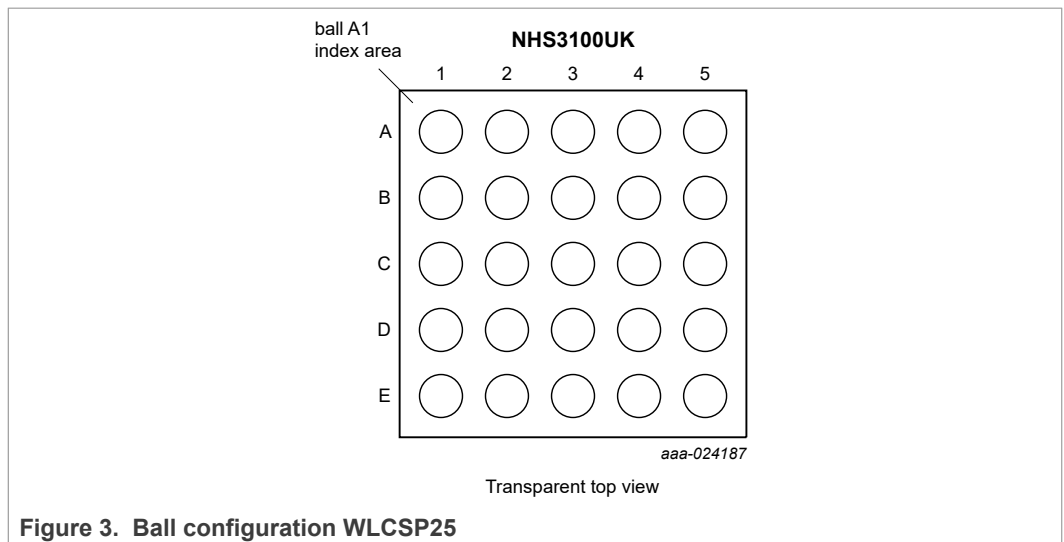


Figure 3. Ball configuration WLCSP25

Table 5. Ball allocation table of the WLCSP25 package

| Ball | Symbol | Ball | Symbol |
|-------------------|------------------------|-------------------|------------------------|
| A1 | VDDBAT | C4 ^[1] | PIO0_7/CT16B_M1 |
| A2 | VSS | C5 ^[1] | PIO0_11/CT32B_M1/SWDIO |
| A3 | RESETN | D1 | PIO0_0/WAKEUP |
| A4 | PIO0_4/SCL | D2 | PIO0_1/CLKOUT |
| A5 | PIO0_5/SDA | D3 ^[2] | (reserved) |
| B1 | PIO0_8/MISO | D4 ^[2] | (reserved) |
| B2 | PIO0_9/MOSI | D5 ^[2] | (reserved) |
| B3 | (reserved) | E1 ^[2] | (reserved) |
| B4 ^[1] | PIO0_3/CT16B_M0 | E2 ^[2] | (reserved) |
| B5 ^[1] | PIO0_10/CT32B_M0/SWCLK | E3 ^[2] | (reserved) |
| C1 | PIO0_2/SSEL | E4 | LA |

Table 5. Ball allocation table of the WLCSP25 package...continued

| Ball | Symbol | Ball | Symbol |
|------|-------------|------|--------|
| C2 | PIO0_6/SCLK | E5 | LB |
| C3 | VSS | - | - |

[1] High source current balls. See [Section 8.6.3](#).

[2] These balls must be tied to ground.

Table 6. Ball description of the WLCSP25 package

| Ball | Symbol | Type | Description |
|---------------------------|----------|--------|---|
| Supply | | | |
| A1 | VDDBAT | supply | positive supply voltage |
| A2, C3 | VSS | supply | ground |
| GPIO^[1] | | | |
| D1 | PIO0_0 | I/O | GPIO |
| | WAKEUP | I | deep power-down mode wake-up pin ^[2] |
| D2 | PIO0_1 | I/O | GPIO |
| | CLKOUT | O | clock output |
| C1 | PIO0_2 | I/O | GPIO |
| | SSEL | I | SPI/SSP serial select line |
| B4 | PIO0_3 | I/O | GPIO |
| | CT16B_M0 | O | 16-bit timer match output 0 |
| A4 | PIO0_4 | I/O | GPIO ^[3] |
| | SCL | I/O | I ² C SCL clock line |
| A5 | PIO0_5 | I/O | GPIO ^[3] |
| | SDA | I/O | I ² C SDA data line |
| C2 | PIO0_6 | I/O | GPIO |
| | SCLK | I/O | SPI/SSP serial clock line |
| C4 | PIO0_7 | I/O | GPIO |
| | CT16B_M1 | O | 16-bit timer match output 1 |
| B1 | PIO0_8 | I/O | GPIO |
| | MISO | O | SPI/SSP master-in slave-out line |
| B2 | PIO0_9 | I/O | GPIO |
| | MOSI | I | SPI/SSP master-out slave-in line |
| B5 | PIO0_10 | I/O | GPIO |
| | CT32B_M0 | O | 32-bit timer match output 0 |
| | SWCLK | I | Arm SWD clock |

Table 6. Ball description of the WLCSP25 package...continued

| Ball | Symbol | Type | Description |
|--------------|----------|------|-------------------------------------|
| C5 | PIO0_11 | I/O | GPIO |
| | CT32B_M1 | O | 32-bit timer match output 1 |
| | SWDIO | I/O | Arm SWD I/O |
| Radio | | | |
| E4 | LA | A | NFC antenna/coil terminal A |
| E5 | LB | A | NFC antenna/coil terminal B |
| Reset | | | |
| A3 | RESETN | I | external reset input ^[4] |

- [1] The GPIO port is a 12-bit I/O port with individual direction and function controls for each bit. The operation of port 0 pins depends on the function selected through the IOCONFIG register block.
- [2] If external wake-up is enabled on this pin, it must be pulled HIGH before entering deep power-down mode. To exit deep power-down mode, it must be pulled LOW for a minimum of 100 μs.
- [3] Open drain, no pull-up or pull-down.
- [4] A LOW on this pin resets the device. This reset causes I/O ports and peripherals to take on their default states and processor execution to begin at address 0. It has weak pull-up to V_{dd} or internal NFC voltage (whichever is highest).

7.3 NHS3100W8

Figure 4 shows the bump layout of the NHS3100W8 gold bump version.

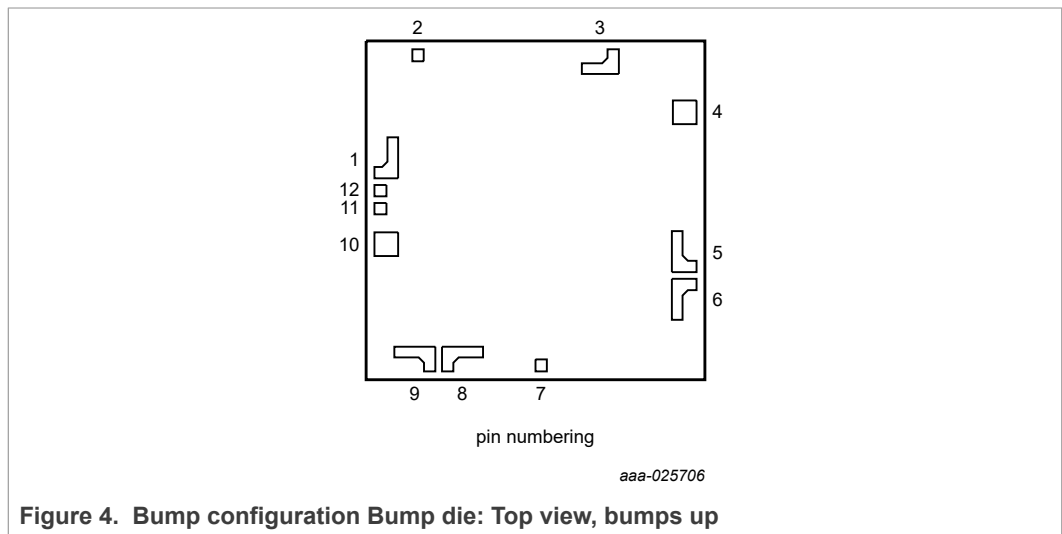


Figure 4. Bump configuration Bump die: Top view, bumps up

Table 7. Bump allocation table of the NHS3100W8 package

| Bump | Symbol | Bump | Symbol |
|------|------------------------|------|--------|
| 1 | PIO0_0/WAKEUP | 7 | TP1 |
| 2 | TP0 | 8 | VSS |
| 3 | LA | 9 | VDDBAT |
| 4 | LB | 10 | PIO0_6 |
| 5 | PIO0_11/CT32B_M1/SWDIO | 11 | TP2 |

Table 7. Bump allocation table of the NHS3100W8 package...continued

| Bump | Symbol | Bump | Symbol |
|------|------------------------|------|--------|
| 6 | PIO0_10/CT32B_M0/SWCLK | 12 | TP3 |

Table 8. Bump description of the NHS3100W8 package

| Bump | Symbol | Type | Description |
|---------------------------|----------|--------|---|
| Supply | | | |
| 9 | VDDBAT | supply | positive supply voltage |
| 8 | VSS | supply | ground |
| GPIO^[1] | | | |
| 1 | PIO0_0 | I/O | GPIO |
| | WAKEUP | I | Deep power-down mode wake-up pin ^[2] |
| 10 | PIO0_6 | I/O | GPIO |
| 6 | PIO0_10 | I/O | GPIO |
| | CT32B_M0 | O | 32-bit timer match output 0 |
| | SWCLK | I | Arm SWD clock |
| 5 | PIO0_11 | I/O | GPIO |
| | CT32B_M1 | O | 32-bit timer match output 1 |
| | SWDIO | I/O | Arm SWD I/O |
| Radio | | | |
| 3 | LA | A | NFC antenna/coil terminal A |
| 4 | LB | A | NFC antenna/coil terminal B |
| Test pins | | | |
| 2 | TP0 | - | test pin - do not connect |
| 7 | TP1 | - | test pin - do not connect, or connect to ground |
| 11 | TP2 | - | test pin - do not connect |
| 12 | TP3 | - | test pin - do not connect |

[1] The GPIO port is a 12-bit I/O port with individual direction and function controls for each bit. The operation of port 0 balls depends on the function selected through the IOCONFIG register block.

[2] If external wake-up is enabled on this ball, it must be pulled HIGH before entering deep power-down mode and pulled LOW for a minimum of 100 μ s to exit deep power-down mode.

8 Functional description

8.1 Arm Cortex-M0+ core

See the *Cortex-M0+ Devices Technical Reference Manual* ([Ref. 1](#)) for a detailed description of the Arm Cortex-M0+ processor.

The NHS3100 Arm Cortex-M0+ core has the following configuration:

- System options
 - Nested vectored interrupt controller (NVIC)
 - Fast (single-cycle) multiplier
 - System tick timer
 - Support for wake-up interrupt controller
 - Vector table remapping register
 - Reset of all registers
- Debug options
 - Serial wire debug (SWD) with two watchpoint comparators and four breakpoint comparators
 - Halting debug is supported

8.2 Memory map

[Figure 5](#) shows the memory and peripheral address space of the NHS3100.

The only AHB peripheral device on the NHS3100 is the GPIO module. The APB peripheral area is 512 kB in size. Each peripheral is allocated 16 kB of space.

All peripheral register addresses are 32-bit word aligned. Byte and halfword addressing is not possible. All reading and writing are done per full word.

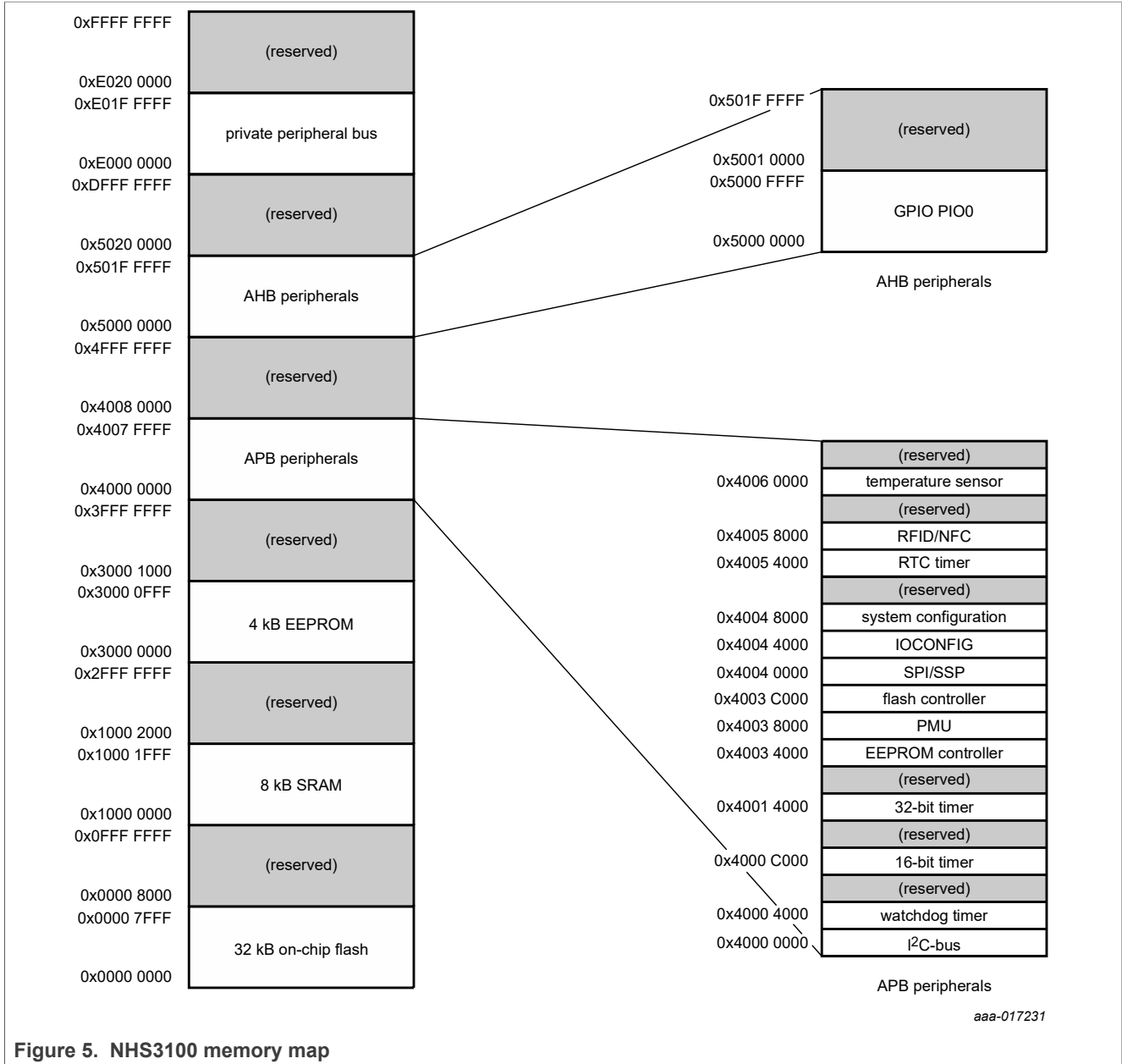


Figure 5. NHS3100 memory map

8.3 System configuration

The system configuration APB block controls oscillators, start logic, and clock generation of the NHS3100. A register for remapping the interrupt vector table is also included in this block.

8.3.1 Clock generation

The NHS3100 clock generator unit (CGU) includes two independent RC oscillators. These oscillators are the system free-running oscillator (SFRO) and the timer free-running oscillator (TFRO).

The SFRO runs at 8 MHz from which the system clock is derived. The system clock can be set to 8 MHz, 4 MHz, 2 MHz, 1 MHz, 500 kHz, 250 kHz, 125 kHz, or 62.5 kHz.

Note: Some features are not available when using the lower clock speeds.

The TFRO runs at 32.768 kHz and is the clock source for the timer unit. The TFRO cannot be disabled.

Following reset, the NHS3100 starts operating at the default 500 kHz system clock frequency to minimize dynamic current consumption during the boot cycle.

The SYSAHBCLKCTRL register gates the system clock to the various peripherals and memories. The temperature sensor receives a fixed clock frequency, irrespective of the system clock divider settings, while the digital part uses the system clock (AHB clock 0).

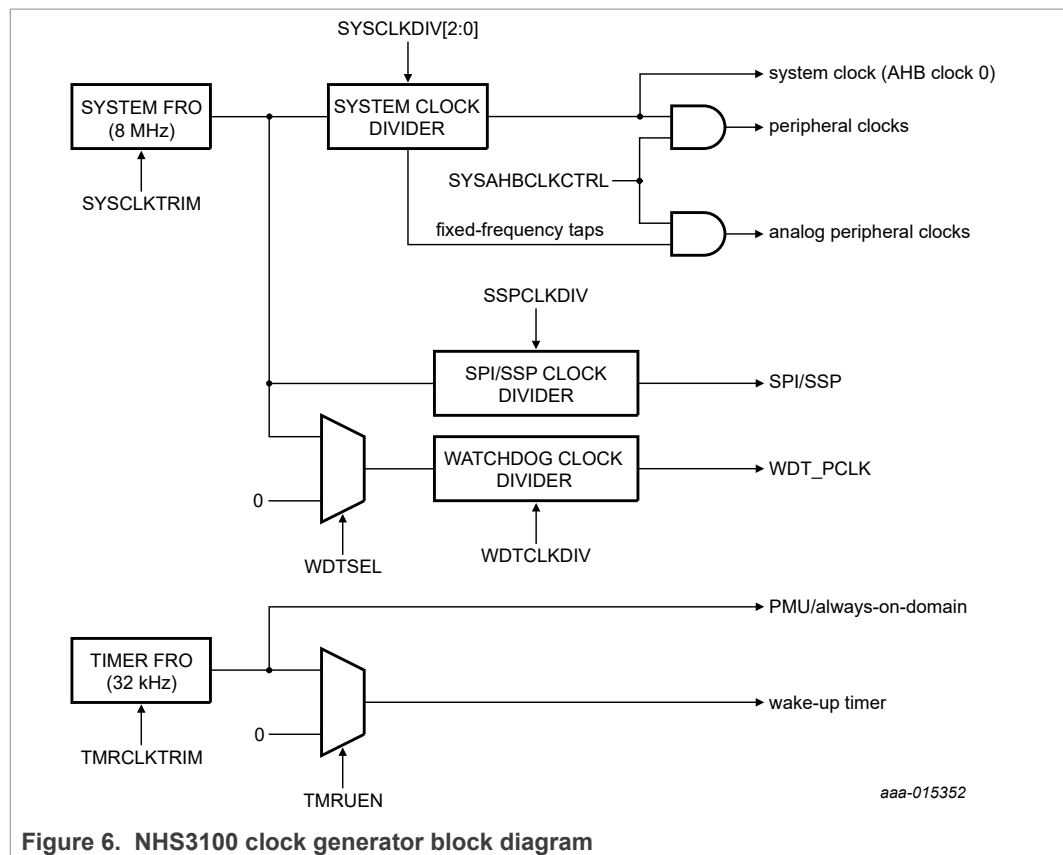


Figure 6. NHS3100 clock generator block diagram

8.3.2 Reset

Reset has three sources on the NHS3100:

- RESETN pin
- Watchdog reset
- Software reset

8.4 Power management

The power management unit (PMU) controls the switching between available power sources and the powering of the different voltage domains in the IC.

8.4.1 System power architecture

The NHS3100 accepts power from two different sources: from the external power supply pin VDDBAT or from the built-in NFC/RFID rectifier.

The NHS3100 has a small automatic source selector that monitors the power inputs (VBAT and VNFC, see [Figure 7](#)) as well as pin RESETN. The PSWBAT switch is kept open until a trigger is given on pin RESETN or via the NFC field. If the trigger is given, the always-on domain, VDD_ALON, itself is powered via the PSWBAT or the PSWNFC switch: via VBAT, if VBAT > 1.72 V, or VNFC. Priority is given to VBAT when both VBAT and VNFC are present.

The automatic source selector unit in the PMU decides on the powering of the internal domains based on the power source.

- If a voltage > 1.72 V is detected on VBAT and not VNFC, VBAT powers the internal domains after a trigger on pin RESETN or via NFC.
- If a voltage ≤ 1.72 V is detected on VBAT, and a higher voltage is detected on VNFC, the internal domains are powered from VNFC.
- If a voltage > 1.72 V is detected at both VBAT and VNFC, the internal domains are powered from VBAT.
- Switch-over between power sources is possible. If both VBAT and VNFC are available initially, the system is powered from VBAT. If VBAT then becomes unavailable (because it is switched off externally, or by a PSWBAT/PSWNFC power switch override), the internal domains are immediately powered from VNFC. Switchover is supported in both directions.
- The user can force the selection of the VBAT input by disabling the automatic power switch, which disables the automatic source selector voltage comparator.

When on NFC power only (passive operation), connect one or more 100 nF external capacitors in parallel to a GPIO pad and set that pad as an output driven to logic 1. Choosing a high-drive pin is preferred. Several pins can be connected in parallel.

PSWNFC and PSWBAT are the power switches. When an RF field is present, PSWNFC connects power to the VDD_ALON power net. When a positive edge is detected on RESETN, PSWBAT connects power from the battery. If no RF power is available, the PMU can open this PSWBAT switch, effectively switching off the device. After connecting VDDBAT to a power source, the PSWBAT switch is open until a rising edge is detected on RESETN or RF power is applied.

Each component of the NHS3100 resides in one of several internal power domains, as indicated in [Figure 7](#). The domains are VBAT, VNFC, VDD_ALON, VDD1V2 and VDD1V6. The domains VDD_ALON, VDD1V2 and VDD1V6 are either powered or not powered, depending on the mode of the NHS3100. There are 5 modes:

- Active
- Sleep
- Deep-sleep
- Deep power-down
- Battery-off

The VDD_ALON domain contains brownout detection (BOD). When this feature is enabled, it raises a BOD interrupt if the VDD_ALON voltage drops below 1.8 V.

The PMU controls the active, sleep, deep-sleep, and deep power-down modes and so also the power flow to the different internal components.

The PMU has two LDOs powering the internal VDD1V2 and VDD1V6 voltage domains. LDO1V2 converts voltages in the range 1.72 V to 3.6 V to 1.22 V. LDO1V6 converts voltages in the range 1.72 V to 3.6 V to 1.6 V. Each LDO can be enabled separately. When powered via VNFC, a 1.2 nF buffer capacitor is included at the input of the LDOs.

To allow for long shelf life before activation, the trigger detector (not shown in [Figure 7](#)) and the power gate have a leakage of less than 50 nA.

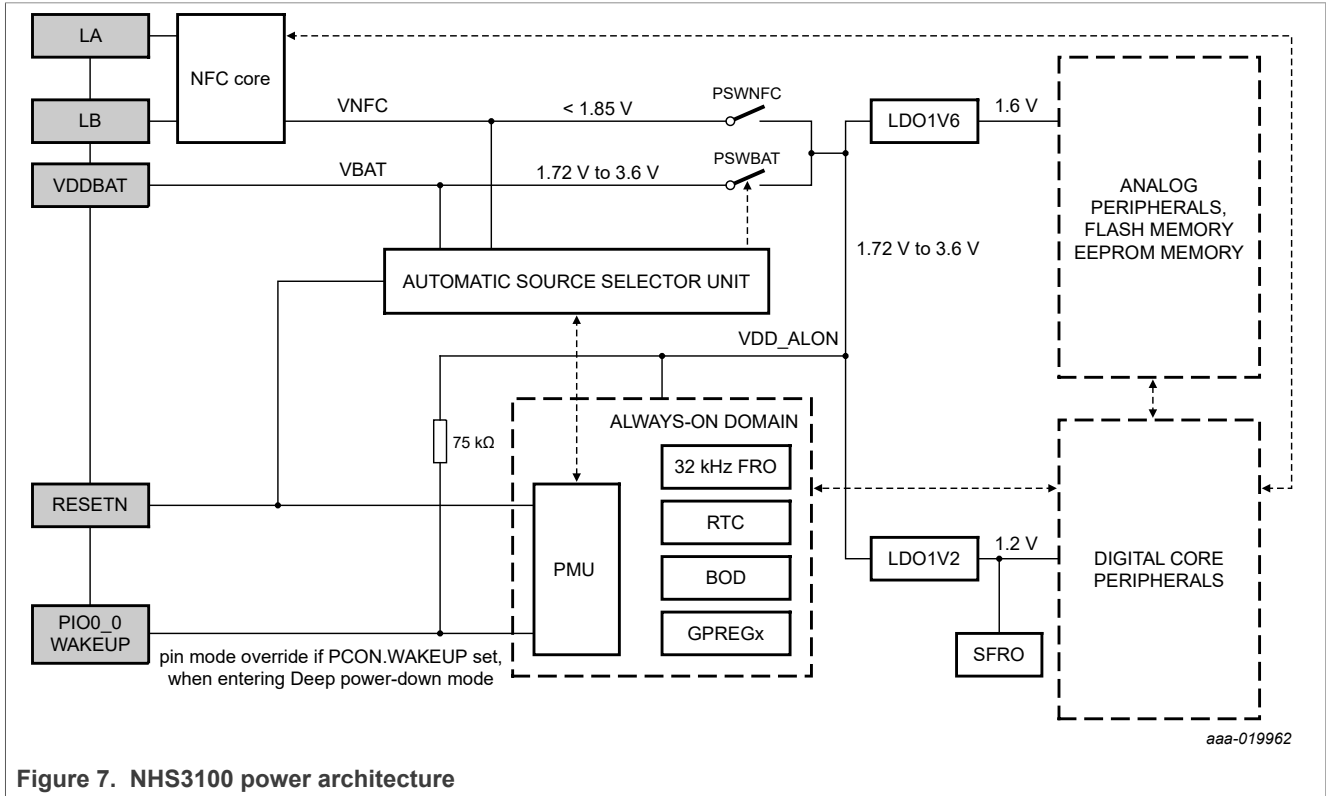


Figure 7. NHS3100 power architecture

The PMU states and settings of the LDOs are summarized in [Table 9](#). [Figure 8](#) shows the state transitions.

[Table 10](#) and [Table 11](#) summarize the events that can influence wake-up from deep power-down or deep-sleep modes (DEEPPDN or DEEPSLEEP to ACTIVE state transition).

Table 9. IC power states

| State | VDD_ALON | Deep power-down mode ^[1] | sleep or deep-sleep mode | LDO1 (1.2 V) | LDO2 (1.6 V) |
|------------------------|----------|-------------------------------------|--------------------------|--------------|--------------|
| BATTERY-OFF (No power) | no | X ^[2] | X ^[2] | off | off |
| ACTIVE | yes | 0 | 0 | on | on |
| DEEPPDN | yes | 1 | 0 | off | off |
| SLEEP/DEEPSLEEP | yes | 0 | 1 | on | on |

[1] DPDN indicates whether the system is in deep power-down mode.

[2] X = don't care.

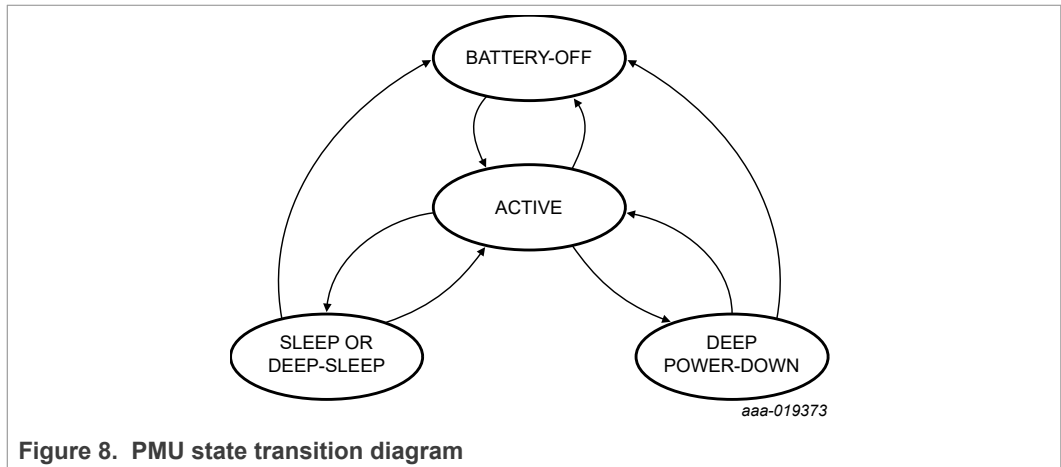


Figure 8. PMU state transition diagram

Figure 9 shows the power-up sequence. Applying battery power when the PSWBAT switch is closed or NFC power becomes available, provides the always-on part with a power-on reset (POR) signal. The TFRO is initiated which starts a state machine in the PMU. In the first state, the LDO1V2 powering the digital domain is started. In the second state, the LDO1V6 powering the analog domain is started which starts the flash memory. Enabling the LDO1V2, and the SFRO stabilizing, triggers the system_por. The system is now considered to be 'on'. When the flash memory is fully operational, the system can boot.

The total start-up time from trigger to active mode/boot is about 2.5 ms.

If there is no battery power, but RF power is available, the same procedure is followed except that PSWNFC connects power to the LDOs.

The user cannot disable the TFRO as it is used by the PMU.

Table 10. State transition events for DEEP SLEEP to ACTIVE

| Event | Description |
|-----------------------|---|
| RESETN | reset asserted |
| RTC event | if the timer reaches preset value |
| Watchdog | watchdog issues interrupt or reset |
| WAKEUP | signal on WAKEUP pin |
| RF field | RF field is detected, potential NFC command input (if set in PMU) |
| Start logic interrupt | one of the enabled start logic interrupts is asserted |

Table 11. State transition events for DEEP POWER DOWN to ACTIVE

| Event | Description |
|-----------|---|
| RESETN | reset asserted |
| RTC event | if the timer reaches preset value |
| WAKEUP | signal on WAKEUP pin (when enabled) |
| RF field | RF field is detected, potential NFC command input (if set in PMU) |

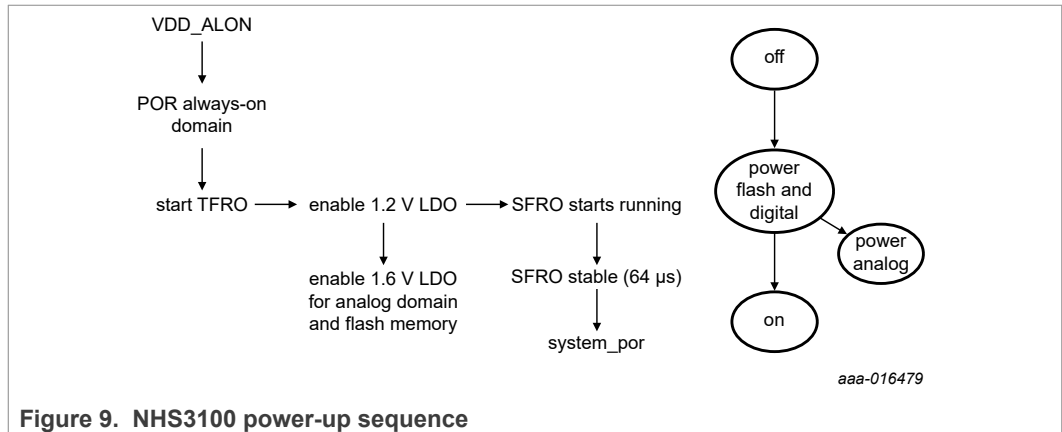


Figure 9. NHS3100 power-up sequence

8.4.2 Power management unit (PMU)

The power management unit (PMU) partly resides in the digital power domain and partly in the always-on domain. The PMU controls the sleep, deep-sleep, and deep power-down modes and the power flow to the different internal circuit blocks. Five general-purpose registers in the PMU can be used to retain data during deep power-down mode. These registers are located in the always-on domain. If VDD_ALON drops to below 1.8 V, the PMU also raises a BOD interrupt when it is configured.

The power to the different APB analog slaves is controlled through a power-down configuration register.

The power control register selects if an Arm Cortex-M0+ controlled power-down mode (sleep mode or deep-sleep mode) or the deep power-down mode is entered. It also provides the flags for sleep or deep-sleep and deep power-down modes, respectively. In addition, it contains the overrides for the power source selection.

8.5 Nested vectored interrupt controller (NVIC)

The nested vectored interrupt controller (NVIC) is a part of the Arm Cortex-M0+. The tight integration of the processor core and NVIC enables fast processing of interrupts, dramatically reducing the interrupt latency.

8.5.1 Features

- NVIC that is a part of the Arm Cortex-M0+
- Tightly coupled interrupt controller provides low interrupt latency
- Controls system exceptions and peripheral interrupts
- Four programmable interrupt priority levels with hardware priority level masking
- Software interrupt generation

8.5.2 Interrupt sources

[Table 12](#) lists the interrupt sources for each peripheral function. Each peripheral device may have one or more interrupt lines to the nested vectored interrupt controller (NVIC). Each line may represent more than one interrupt source. There is no significance or priority about which line is connected where, except for certain standards from Arm.

Table 12. Connection of interrupt source to the nested vectored interrupt controller

| Exception number | Vector offset | Function | Flags |
|------------------|---------------|--------------------------------|--|
| 0 to 12 | - | start logic wake-up interrupts | each interrupt connected to a PIO0 input pin serves as wake-up from deep-sleep mode ^[1] |
| 13 | - | RFID/NFC | RFID/NFC access detected/command received/read acknowledge |
| 14 | - | RTC On/Off timer | RTC on/off timer event interrupt |
| 15 | - | I ² C | slave input (SI) (state change) |
| 16 | - | CT16B | 16-bit timer |
| 17 | - | PMU | power from NFC field detected |
| 18 | - | CT32B | 32-bit timer |
| 19 | - | BOD | brownout detection (power drop) |
| 20 | - | SPI/SSP | TX FIFO half empty/RX FIFO half full/RX time-out/RX overrun |
| 21 | - | TSENS | temperature sensor end of conversion/low threshold/high threshold |
| 22 to 25 | - | - | (reserved) |
| 26 | - | WDT | watchdog interrupt (WDINT) |
| 27 | - | flash | flash memory |
| 28 | - | EEPROM | EEPROM memory |
| 29 to 30 | - | - | (reserved) |
| 31 | - | PIO0 | GPIO interrupt status of port 0 |

[1] Interrupt 0 to 10 correspond to PIO0_0 to PIO0_10; Interrupt 11 corresponds to RFID/NFC external access; Interrupt 12 corresponds to the RTC on/off timer.

8.6 I/O configuration

The I/O configuration registers control the electrical characteristics of the pads. The following features are programmable:

- Pin function
- Internal pull-up/pull-down resistor or bus keeper function
- Low-pass filter
- I²C-bus mode for pads hosting the I²C-bus function

The IOCON registers control the function (GPIO or peripheral function), the input mode, and the hysteresis of all PIO0_m pins. In addition, the I²C-bus pins can be configured for different I²C-bus modes.

The FUNC bits in the IOCON registers can be set to GPIO (FUNC = 000) or to a peripheral function. If the pins are GPIO pins, the GPIO0DIR registers determine if the pin is configured as an input or output. For any peripheral function, the pin direction is controlled automatically depending on the functionality of the pin. The GPIO0DIR registers have no effect on peripheral functions.

8.6.1 PIO0 pin mode

The MODE bits in the IOCON register allow the selection of on-chip pull-up or pull-down resistors for each pin or to select the repeater mode. The possible on-chip resistor configurations are pull-up enabled, pull-down enabled, or no pull-up/pull-down. The default value is no pull-up or pull-down enabled. When the pin is at logic 1, the repeater mode enables the pull-up resistor. When the pin is at logic 0, it enables the pull-down resistor. If this mode is configured as an input and is not driven externally, it causes the pin to retain its last known state. The state retention is not applicable to the deep power-down mode. Repeater mode is typically used to prevent a pin from floating when it is temporarily not driven. Allowing it to float can use significant power.

8.6.2 PIO0 I²C-bus mode

If the FUNC bits of registers PIO0_4 and PIO0_5 select the I²C-bus function, the I²C-bus pins can be configured for different I²C-bus modes:

- Standard-mode/Fast-mode I²C-bus with input glitch filter (including an open-drain output according to the I²C-bus specification)
- Standard open-drain I/O functionality without input filter

8.6.3 PIO0 current source mode

PIO0_3, PIO0_7, PIO0_10, and PIO0_11 are high-source pads that can deliver up to 20 mA to the load. These PIO pins can be set to either digital mode or analog current sink mode. In digital mode, the output voltage of the pad switches between VSS and VDD. In analog current drive mode, the output current sink switches between the values set by the ILO and IHI bits. The maximum pad voltage is limited to 5 V.

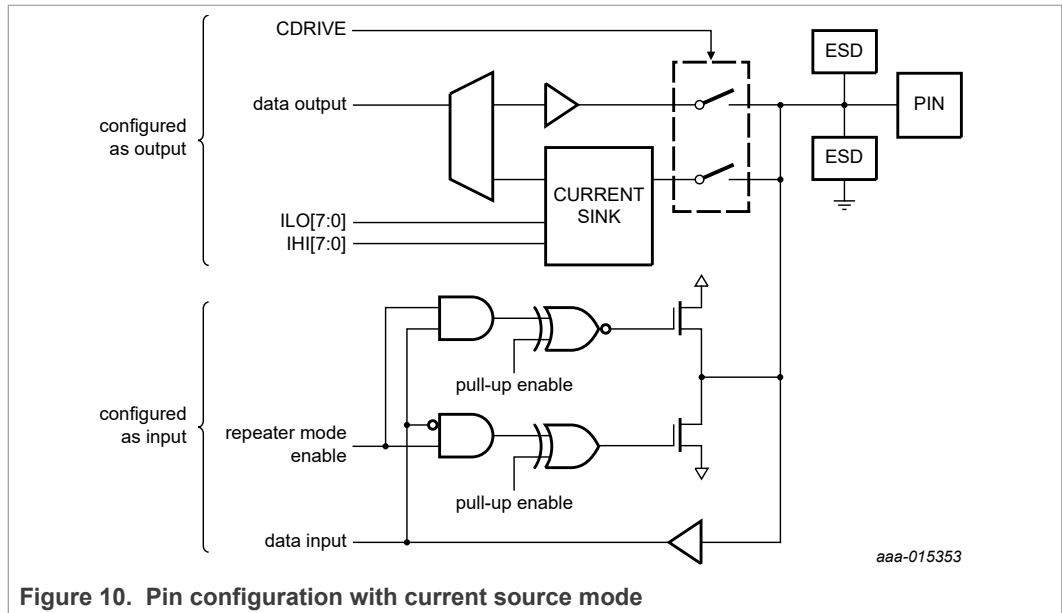


Figure 10. Pin configuration with current source mode

8.7 Fast general-purpose parallel I/O

The general-purpose I/O (GPIO) registers control device pins that are not connected to a specific peripheral function. Pins may be dynamically configured as inputs or outputs. Multiple outputs can be set or cleared in one write operation.

The NHS3100 uses accelerated GPIO functions:

- GPIO registers are on the Arm Cortex-M0+ I/O bus for fastest possible single-cycle I/O timing
- An entire port value can be written in one instruction
- Mask, set, and clear operations are supported for the entire port

All GPIO port pins are fixed pin functions. The switch matrix enables or disables these functions on the pins. So, each GPIO port pin is assigned to one specific pin and cannot be moved to another pin.

8.7.1 Features

- Bit level port registers allow a single instruction to set and clear any number of bits in one write operation
- Direction control of individual bits
- After reset, all I/Os default to GPIO inputs without pull-up or pull-down resistors. The I²C-bus true open-drain pins PIO0_4 and PIO0_5 and the SWD pins PIO0_10 and PIO0_11 are exceptions
- Pull-up/pull-down configuration, repeater, and open-drain modes can be programmed through the IOCON block for each GPIO pin
- Direction (input/output) can be set and cleared individually
- Pin direction bits can be toggled

8.8 I²C-bus controller

8.8.1 Features

Standard I²C-bus compliant ([Ref. 3](#)) interfaces may be configured as master, slave, or master/slave.

- Arbitration is handled between simultaneously transmitting masters without corruption of serial data on the bus
- Programmable clock allows adjustment of I²C-bus transfer rates
- Data transfer is bidirectional between masters and slaves
- Serial clock synchronization allows devices with different bit rates to communicate via one serial bus
- Serial clock synchronization is used as a handshake mechanism to suspend and resume serial transfer
- Supports standard mode (100 kbit/s) and fast mode (400 kbit/s)
- Optional recognition of up to four slave addresses
- Monitor mode allows observing all I²C-bus traffic, regardless of slave address
- The I²C-bus can be used for test and diagnostic purposes
- The I²C-bus contains a standard I²C-bus compliant interface with two pins
- Possibility to wake up NHS3100 on matching I²C-bus slave address

8.8.2 General description

Two types of data transfers are possible on the I²C-bus, depending on the state of the direction bit (R/W):

- Data transfer from a master transmitter to a slave receiver
The first byte transmitted by the master is the slave address. Next follows a number of data bytes. The slave returns an acknowledge bit after each received byte.
- Data transfer from a slave transmitter to a master receiver
The master transmits the first byte (the slave address). The slave then returns an acknowledge bit. The slave then transmits the data bytes to the master. The master returns an acknowledge bit after all received bytes other than the last byte. At the end of the last received byte, a not-acknowledge is returned. The master device generates all of the serial clock pulses and the START and STOP conditions. A transfer is ended with a STOP condition or with a repeated START condition. As a repeated START condition is also the beginning of the next serial transfer, the I²C-bus is not released.

The I²C-bus interface is byte oriented and has four operating modes:

- Master transmitter mode
- Master receiver mode
- Slave transmitter mode
- Slave receiver mode

The I²C-bus interface is completely I²C-bus compliant. It supports power-off of the NHS3100 independent of other devices on the same I²C-bus.

The I²C-bus interface requires a minimum 2 MHz system clock to operate in normal mode. It requires 8 MHz for fast mode.

8.8.3 I²C-bus pin description

Table 13. I²C-bus pin description

| Pin | Type | Description |
|-----|------|-----------------------------------|
| SDA | I/O | I ² C-bus serial data |
| SCL | I/O | I ² C-bus serial clock |

The I²C-bus pins must be configured through the PIO0_4 and PIO0_5 registers for standard mode or fast mode. The I²C-bus pins are open-drain outputs and fully compatible with the I²C-bus specification.

8.9 SPI controller

8.9.1 Features

- Compatible with Motorola SPI, 4-wire Texas Instruments Synchronous Serial Interface (SSI), and National Semiconductor Microwire buses
- Synchronous serial communication
- Supports master or slave operation
- Eight-frame FIFOs for both transmit and receive
- 4-bit to 16-bit frame

8.9.2 General description

The SPI/SSP is a synchronous serial port (SSP) controller capable of operation on an SPI, 4-wire SSI, or Microwire bus. It can interact with multiple masters and slaves on the bus. Only a single master and a single slave can communicate on the bus during a given data transfer. Data transfers are in principle full duplex, with frames of 4 bits to 16 bits of bidirectional data flowing between master and slave. In practice, often only one of these two data flows carries meaningful data.

8.9.3 Pin description

Table 14. SPI pin description

| Pin name | Type | Interface pin SPI | SSI | Microwire | Description |
|----------|------|-------------------|------------------|------------------|---------------------------|
| SCLK | I/O | SCLK | CLK | SK | serial clock |
| SSEL | I/O | SSEL | FS | CS | frame sync/slave select |
| MISO | I/O | MISO | DR (M) DX (S) | SI (M) SO (S) | master input slave output |
| MOSI | I/O | MOSI | DX (M) DR (S) | SO (M) SI (S) | master output slave input |

8.9.3.1 Pin detailed description

Serial clock

SCK/CLK/SK is a clock signal used to synchronize the transfer of data. The master drives the clock signal and the slave receives it. When SPI/SSP interface is used, the clock is programmable to be active HIGH or active LOW, otherwise it is always active

HIGH. SCK only switches during a data transfer. At any other time, the SPI/SSP interface either stays in its inactive state or is not driven (remains in high-impedance state).

Frame sync/slave select

When the SPI/SSP interface is a bus master, it drives this signal to an active state before the start of serial data. It then releases it to an inactive state after the data has been sent. The active state can be HIGH or LOW depending upon the selected bus and mode. When the SPI/SSP interface is a bus slave, this signal qualifies the presence of data from the master according to the protocol in use.

When there is only one master and slave, the master signals, frame sync, or slave select, can be connected directly to the corresponding slave input. When there are multiple slaves, further qualification of frame sync/slave select inputs is normally necessary to prevent more than one slave from responding to a transfer.

Master input slave output (MISO)

The MISO signal transfers serial data from the slave to the master. When the SPI/SSP is a slave, it outputs serial data on this signal. When the SPI/SSP is a master, it clocks in serial data from this signal. It does not drive this signal and leaves it in a high-impedance state when the SPI/SSP is a slave and not selected by FS/SSEL.

Master output slave input (MOSI)

The MOSI signal transfers serial data from the master to the slave. When the SPI/SSP is a master, it outputs serial data on this signal. When the SPI/SSP is a slave, it clocks in serial data from this signal.

8.10 RFID/NFC communication unit

8.10.1 Features

- ISO/IEC14443A part 1 to part 3 compatible
- MIFARE (Ultralight) EV1 compatible
- NFC Forum Type 2 compatible
- Easy interfacing with standard user memory space READ/WRITE commands
- Passive operation possible

8.10.2 General description

The RFID/NFC interface allows communication using 13.56 MHz proximity signaling.

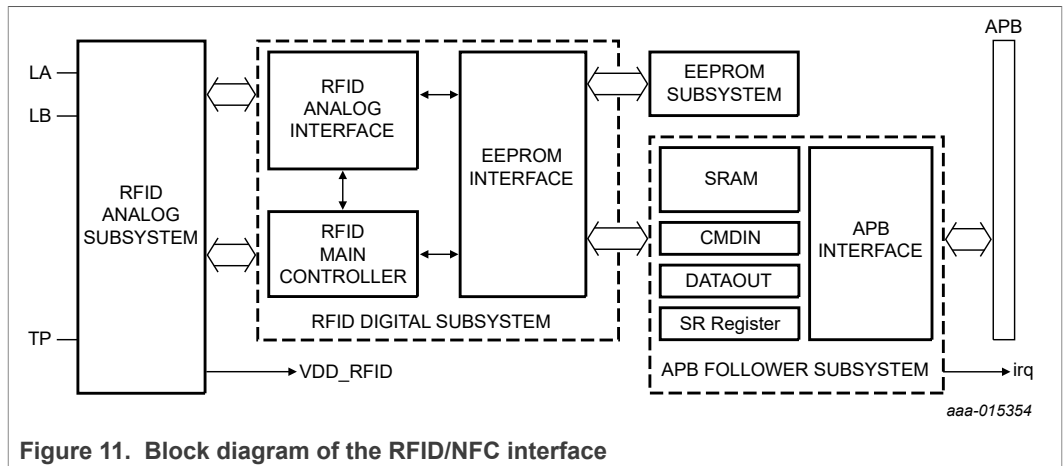


Figure 11. Block diagram of the RFID/NFC interface

The CMDIN, DATAOUT, status register (SR), and SRAM are mapped in the user memory space of the RFID core. The RFID READ and WRITE commands allow wireless communication to this shared memory.

Messages can be in raw mode (user proprietary protocol) or formatted according to NFC Forum Type 2 NDEF messaging and ISO/IEC 11073.

8.11 16-bit timer

8.11.1 Features

One 16-bit timer with a programmable 16-bit prescaler.

- Timer operation
- Four 16-bit match registers that allow:
 - Continuous operation with optional interrupt generation on match
 - Stop timer on match with optional interrupt generation
 - Reset timer on match with optional interrupt generation
- Up to two CT16B external outputs corresponding to the match registers with the following capabilities:
 - Set LOW on match
 - Set HIGH on match
 - Toggle on match
 - Do nothing on match
- Up to two match registers can be configured as pulse width modulation (PWM). It allows the use of up to two match outputs as single edge controlled PWM outputs

8.11.2 General description

The peripheral clock (PCLK), which is derived from the system clock, clocks the timer. The timer can optionally generate interrupts or perform other actions at specified timer values based on four match registers. The peripheral clock is provided by the system clock.

Each timer also includes one capture input to trap the timer value when an input signal transitions, optionally generating an interrupt.

In PWM mode, four match registers can be used to provide a single-edge controlled PWM output on the match output pins. The use of the match registers that are not pinned out to control the PWM cycle length is recommended.

8.12 32-bit timer

8.12.1 Features

One 32-bit timer with a programmable 32-bit prescaler.

- Timer operation
- Four 32-bit match registers that allow:
 - Continuous operation with optional interrupt generation on match
 - Stop timer on match with optional interrupt generation
 - Reset timer on match with optional interrupt generation
- Up to two CT32B external outputs corresponding to the match registers with the following capabilities:
 - Set LOW on match
 - Set HIGH on match
 - Toggle on match
 - Do nothing on match
- Up to two match registers can be configured as PWM allowing the use of up to two match outputs as single edge controlled PWM outputs

8.12.2 General description

The peripheral clock (PCLK), which is derived from the system clock, clocks the timer. The timer can optionally generate interrupts or perform other actions at specified timer values based on four match registers. The peripheral clock is provided by the system clock.

Each timer also includes one capture input to trap the timer value when an input signal transitions, optionally generating an interrupt.

In PWM mode, four match registers can be used to provide a single-edge controlled PWM output on the match output pins. Use of the match registers that are not pinned out to control the PWM cycle length is recommended.

8.13 Watchdog timer (WDT)

If the microcontroller enters an erroneous state, the purpose of the watchdog timer (WDT) is to reset it within a reasonable amount of time.

When enabled, if the user program fails to feed (or reload) the WDT within a predetermined amount of time, the WDT generates a system reset.

8.13.1 Features

- If not periodically reloaded, it internally resets the microcontroller
- Debug mode
- Enabled by software but requires a hardware reset or a WDT reset/interrupt to be disabled
- If enabled, incorrect/incomplete feed sequence causes reset/interrupt
- Flag to indicate WDT reset
- Programmable 24-bit timer with internal prescaler
- Selectable time period from $(\text{TWDCLK} \times 256 \times 4)$ to $(\text{TWDCLK} \times 2^{24} \times 4)$ in multiples of $\text{TWDCLK} \times 4$

- The WDT clock (WDCLK) source is a 2 MHz clock derived from the SFRO, or the external clock as set by the SYCLKCTRL register

8.13.2 General description

The WDT consists of a divide by four fixed prescaler and a 24-bit counter. The clock is fed to the timer via a prescaler. The timer decrements when clocked. The minimum value by which the counter is decremented is 0xFF. Setting a value lower than 0xFF causes 0xFF to be loaded in the counter. Hence, the minimum WDT interval is $(\text{TWDCCLK} \times 256 \times 4)$ and the maximum is $(\text{TWDCCLK} \times 2^{24} \times 4)$, in multiples of $(\text{TWDCCLK} \times 4)$.

8.14 System tick timer

8.14.1 Features

- Simple 24-bit timer
- Uses dedicated exception vector
- Clocked internally by the system clock or the system clock divided by two

8.14.2 General description

The SYSTICK timer is a part of the Cortex-M0+. The SYSTICK timer can be used to generate a fixed periodic interrupt for use by an operating system or other system. Since the SYSTICK timer is a part of the Cortex-M0+, it facilitates porting of software by providing a standard timer available on Cortex-M0+-based devices. The SYSTICK timer can be used for management software.

See the Cortex-M0+ Devices - Generic User Guide ([Ref. 2](#)) for details.

8.15 Real-time clock (RTC) timer

8.15.1 Features

The real-time clock (RTC) block contains two counters:

- A countdown timer generating a wake-up signal when it expires.
- A continuous counter that counts seconds since power-up or the last system reset

The countdown timer runs on a low-speed clock and runs in an always-on power domain. The delay and a clock tuning prescaler can be configured via the APB bus. The RTC countdown timer generates the deep power-down wake-up signal and the RTC interrupt signal (wake-up interrupt 12). The deep power-down wake-up signal is always generated, while the interrupt can be masked according to the settings in the RTCIMSC register.

8.15.2 General description

The RTC module consists of two parts:

- The RTC core module, implementing the RTC timers themselves. This module runs in the always-on VDD_ALON domain.
- The AMBA APB slave interface. This module allows configuration of the RTC core via an APB bus. It runs in the switched power domain.

8.16 Temperature sensor

8.16.1 Features

The temperature sensor block measures the chip temperature and outputs a raw value or a calibrated value in Kelvin.

8.16.2 General description

The temperature is measured using a high-precision, zoom-ADC. The analog part is able to measure a highly temperature-dependent $X = V_{be} / \Delta V_{be}$ ¹. It determines the value of X by first applying a coarse search (successive approximation) and then a sigma-delta in a limited range. The conversion time depends on the resolution mode as shown in [Table 15](#).

Table 15. Conversion time for different resolution of TSEN

| Resolution (bit) | Resolution (°C) | Conversion time (ms) |
|------------------|-----------------|----------------------|
| 7 | ±0.8 | 4 |
| 8 | ±0.4 | 7 |
| 9 | ±0.2 | 14 |
| 10 | ±0.1 | 26 |
| 11 | ±0.05 | 50 |
| 12 | ±0.025 | 100 |

8.17 Serial wire debug (SWD)

The debug functions are integrated into the Arm Cortex-M0+. Serial wire debug (SWD) functions are supported. The Arm Cortex-M0+ is configured to support up to four breakpoints and two watchpoints.

- Supports Arm SWD mode
- Direct debug access to all memories, registers, and peripherals
- No target resources are required for the debugging session
- Four instruction breakpoints that can also be used to remap instruction addresses for code patches.
 - Two data comparators that can be used to remap addresses for patches to literal values.
- Two data watchpoints that can also be used as triggers

¹ V_{be} is the base-emitter voltage of a bipolar transistor. Basically, the temperature sensor measures the voltage drop over a diode formed by the base-emitter junction of a bipolar transistor. It compares the V_{be} at different current levels (from which follows the ΔV_{be}).

8.18 On-chip flash memory

The NHS3100 contains a 32 kB flash memory of which 30 kB can be used as program and data memory.

The flash is organized in 32 sectors of 1 kB. Each sector consists of 16 rows of 16×32 -bit words.

8.18.1 Reading from flash

Reading is done via the AHB interface. The memory is mapped on the bus address space as a contiguous address space. Memory data words are seen on the bus using a little endian arrangement.

8.18.2 Writing to flash

Writing to flash means copying a word of data over the AHB to the page buffer of the flash. It does not actually program the data in the memory array. Subsequent erase and program cycles do this programming.

8.18.3 Erasing/programming flash

Erasing and programming are separate operations. Both are only possible on memory sectors that are unprotected and unlocked. Protect/lock information is stored inside the memory itself, so the controller is not aware of protection status. So, if a program/erase operation is performed on a protected or locked sector, it does not flag an error.

- **Protection:**

At the exit from reset, all sectors are protected against accidental modification. To allow modifications, a sector must be unprotected. It can then be protected again after that the modification has been performed.

- **Locking:**

Each flash sector has a lock bit. Lock bits can be set but cannot be cleared. Locked sectors cannot be erased and reprogrammed.

8.19 On-chip SRAM

The NHS3100 contains a total of 8 kB on-chip SRAM memory configured as $256 \times 2 \times 4 \times 32$ bit.

8.20 On-chip EEPROM

The NHS3100 contains a 4 kB EEPROM. This EEPROM is organized in 64 rows of 32×16 -bit words. Of these rows, the last four contain calibration and test data and are locked. The boot loader uses this data or it is made accessible to the application via the firmware application programming interface (API).

8.20.1 Reading from EEPROM

Reading is done via the AHB interface. The memory is mapped on the bus address space, as a contiguous address space. Memory data words are seen on the bus using a little endian arrangement.

8.20.2 Writing to EEPROM

Erasing and programming is performed, as a single operation, on one or more words inside a single page.

Previous write operations have transferred the data to be programmed into the memory page buffer. The page buffer tracks which words were written to (offset within the page only). Words not written to, retain their previous content.

9 Limiting values

Table 16. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------|---------------------------------|--|-------|-------|------|
| V_{DD} | supply voltage | | -0.5 | +3.6 | V |
| V_I | input voltage | normal PIO pads ($V_{DD} = 0.6$ V) | -0.5 | +3.6 | V |
| | | high-source PIO pads | -0.5 | +5.5 | V |
| | | LA/LB pads | -0.5 | +5.5 | V |
| I_{DD} | supply current | per supply pin | - | 100 | mA |
| I_{SS} | ground supply current | per supply pin | - | 100 | mA |
| I_{lu} | latch-up current | I/O; $-0.5 V_{DD} < V_I < +1.5 V_{DD}$; $T_j < 125$ °C | - | 100 | mA |
| T_{stg} | storage temperature | | -40 | +125 | °C |
| T_{oper} | operating temperature | | -40 | +85 | °C |
| T_j | junction temperature | | - | 125 | °C |
| P_{tot} | total power dissipation | | - | 1 | W |
| V_{ESD} | electrostatic discharge voltage | human body model; all pins | -2000 | +2000 | V |
| | | charged device model; all pins | -500 | +500 | V |
| | active lifetime | | - | 10 | year |

10 Static characteristics

Table 17. Static characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$, unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit | |
|--------------------------------|--------------------------------|---------------------------------------|-------------|-------|-------------|---------------|----|
| Supply pins | | | | | | | |
| V_{DD} | supply voltage | | 1.72 | 3.0 | 3.60 | V | |
| I_{DD} | supply current | voltage and clock frequency dependent | [1] | - | - | μA | |
| $I_{L(off)}$ | off-state leakage current | | - | - | 50 | nA | |
| $I_{DD(pd)}$ | power-down mode supply current | deep power-down mode | - | 3 | - | μA | |
| Standard GPIO pins | | | | | | | |
| V_{IH} | HIGH-level input voltage | | $0.7V_{DD}$ | - | - | V | |
| V_{IL} | LOW-level input voltage | | - | - | $0.3V_{DD}$ | V | |
| V_{hys} | hysteresis voltage | | 0.4 | - | - | V | |
| R_{pd} | pull-down resistance | | - | 72 | - | k Ω | |
| R_{pu} | pull-up resistance | | - | 73 | - | k Ω | |
| I_S | source current | HIGH-level $V_{DD} = 1.8\text{ V}$ | [2] | - | 2 | - | mA |
| | | HIGH-level $V_{DD} = 3.6\text{ V}$ | [2] | - | 8 | - | mA |
| | | LOW-level $V_{DD} = 1.8\text{ V}$ | [2] | - | 4 | - | mA |
| | | LOW-level $V_{DD} = 3.6\text{ V}$ | [2] | - | 16 | - | mA |
| High-drive GPIO pins | | | | | | | |
| I_S | source current | HIGH-level $V_{DD} = 1.8\text{ V}$ | [3] | 4 | - | 6 | mA |
| | | HIGH-level $V_{DD} = 3.6\text{ V}$ | [3] | 13 | - | 18 | mA |
| | | LOW-level $V_{DD} = 1.8\text{ V}$ | [3] | 5.5 | - | 8 | mA |
| | | LOW-level $V_{DD} = 3.6\text{ V}$ | [3] | 22 | - | 32 | mA |
| I²C-bus pins | | | | | | | |
| I_S | source current | LOW-level $V_{DD} = 1.8\text{ V}$ | [4] | 2 | - | 8.5 | mA |
| | | LOW-level $V_{DD} = 3.6\text{ V}$ | [4] | 9.5 | - | 38 | mA |
| Brownout detect | | | | | | | |
| $V_{trip(bo)}$ | brownout trip voltage | falling V_{DD} | - | 1.8 | - | V | |
| | | rising V_{DD} | - | 1.875 | - | V | |
| V_{hys} | hysteresis voltage | | - | 75 | - | mV | |
| General | | | | | | | |
| $R_{pu(int)}$ | internal pull-up resistance | on pin RESETN | - | 100 | - | k Ω | |
| C_{ext} | external capacitance | on pin RESETN | - | - | 1 | nF | |

[1] See [Figure 12](#)

[2] PIO0_0, PIO0_1, PIO0_2, PIO0_6, PIO0_8, PIO0_9

[3] PIO0_3, PIO0_7, PIO0_10, PIO0_11

[4] PIO0_4, PIO0_5

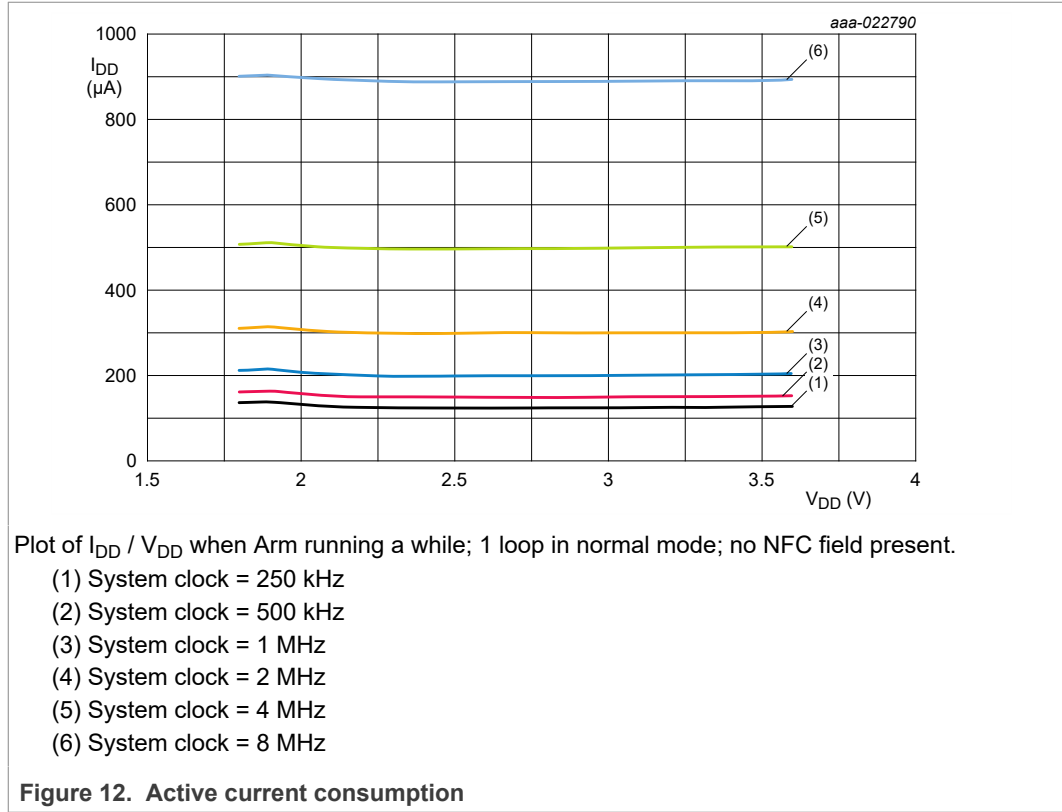


Table 18. Temperature sensor characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------|--------------------------------|--|------|-------|------|--------------------|
| $I_{CC(pd)}$ | power-down mode supply current | TSEN disabled | - | - | 1 | nA |
| I_{stb} | standby current | TSEN enabled | - | 6 | 7 | μ A |
| $I_{CC(oper)}$ | operating supply current | TSEN converting | - | 10 | 12 | μ A |
| T_{acc} | temperature accuracy | $T_{amb} = 0\text{ }^{\circ}\text{C}$ to $+45\text{ }^{\circ}\text{C}$ | -0.3 | - | +0.3 | $^{\circ}\text{C}$ |
| | | $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$ | -0.5 | - | +0.5 | $^{\circ}\text{C}$ |
| T_{res} | temperature resolution | 12-bit mode | - | 0.025 | - | $^{\circ}\text{C}$ |
| | | 8-bit mode | - | 0.4 | - | $^{\circ}\text{C}$ |
| T_{conv} | conversion period | 12-bit mode | - | 100 | - | ms |
| | | 8-bit mode | - | 7 | - | ms |

Note:

All ICs are individually temperature-calibrated in production and ISO/IEC 17025 calibration certificates with NIST traceability are available at nxp.com/NTAGSMARTSENSOR.

The absolute accuracy is valid for the factory calibration of the temperature sensor. The sensor can be user-calibrated to reach higher accuracy.

Table 19. Antenna input characteristics

| Symbol | Parameter | Conditions | | Min | Typ | Max | Unit |
|--------|-------------------|------------|-----|-----|-------|-----|------|
| C_i | input capacitance | | [1] | - | 50 | - | pF |
| f_i | input frequency | | | - | 13.56 | - | MHz |

[1] $T_{amb} = 22\text{ °C}$; $f = 13.56\text{ MHz}$; RMS voltage between LA and LB = 1.5 V

Table 20. EEPROM characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-----------------|---------------------|--------------------------|-----|-----|-----|------|
| $t_{ret(data)}$ | data retention time | $T_{amb} = 22\text{ °C}$ | 10 | - | - | year |

11 Dynamic characteristics

11.1 I/O pins

Table 21. I/O dynamic characteristics

These characteristics apply to standard port pins and RESETN pin. $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--------|-----------|--------------------------|-----|-----|-----|------|
| t_r | rise time | pin configured as output | 3.0 | - | 5.0 | ns |
| t_f | fall time | pin configured as output | 2.5 | - | 5.0 | ns |

11.2 I²C-bus

Table 22. I²C-bus dynamic characteristics

See UM10204 - I²C-bus specification and user manual (Ref. 3) for details. $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$ ^[1]; see the timing diagram in Figure 13.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--------------|---------------------------------------|---------------|-------------|-----------------------|-----|---------------|
| f_{SCL} | SCL clock frequency | Standard mode | 0 | - | 100 | kHz |
| | | Fast mode | 0 | - | 400 | kHz |
| t_f | fall time of both SDA and SCL signals | Standard mode | [2] [3] [4] | - | 300 | ns |
| | | Fast mode | [2] [3] [4] | $20 + 0.1 \times C_b$ | 300 | ns |
| t_{LOW} | LOW period of the SCL clock | Standard mode | 4.7 | - | - | μs |
| | | Fast mode | 1.3 | - | - | μs |
| t_{HIGH} | HIGH period of the SCL clock | Standard mode | 4.0 | - | - | μs |
| | | Fast mode | 0.6 | - | - | μs |
| $t_{HD;DAT}$ | data hold time | Standard mode | [2] [5] [6] | 0 | - | μs |
| | | Fast mode | [2] [5] [6] | 0 | - | μs |
| $t_{SU;DAT}$ | data setup time | Standard-mode | [7] [8] | 250 | - | ns |
| | | Fast-mode | [7] [8] | 100 | - | ns |

[1] Parameters are valid over operating temperature range unless otherwise specified.

[2] A device must internally provide a hold time of at least 300 ns for the SDA signal (regarding the $V_{IH(min)}$ of the SCL signal). The hold time is to bridge the undefined region of the falling edge of SCL.

[3] C_b = total capacitance of one bus line in pF.

[4] The maximum t_f for the SDA and SCL bus lines is specified at 300 ns. The maximum fall time for the SDA output stage t_f is specified at 250 ns. It allows series protection resistors to be connected between the SDA and the SCL pins and the SDA/SCL bus lines without exceeding the maximum specified t_f .

[5] $t_{HD;DAT}$ is the data hold time that is measured from the falling edge of SCL; applies to data in transmission and the acknowledge.

[6] The maximum $t_{HD;DAT}$ could be 3.45 μs and 0.9 μs for standard mode and fast mode. However, it must be less than the maximum of $t_{VD;DAT}$ or $t_{VD;ACK}$ by a transition time (see Ref. 3). Only meet this maximum if the device does not stretch the LOW period (t_{LOW}) of the SCL signal. If the clock stretches the SCL, the data must be valid by the setup time before it releases the clock.

[7] $t_{SU;DAT}$ is the data setup time that is measured against the rising edge of SCL; applies to data in transmission and the acknowledge.

[8] A fast-mode I²C-bus device can be used in a standard-mode I²C-bus system but it must meet the requirement $t_{SU;DAT} = 250$ ns. This requirement is automatically the case if the device does not stretch the LOW period of the SCL signal. If it does, it must output the next data bit to the SDA line $t_{r(max)} + t_{SU;DAT} = 1000 + 250 = 1250$ ns before the SCL line is released. This procedure is in accordance with the standard-mode I²C-bus specification. Also, the acknowledge timing must meet this setup time.

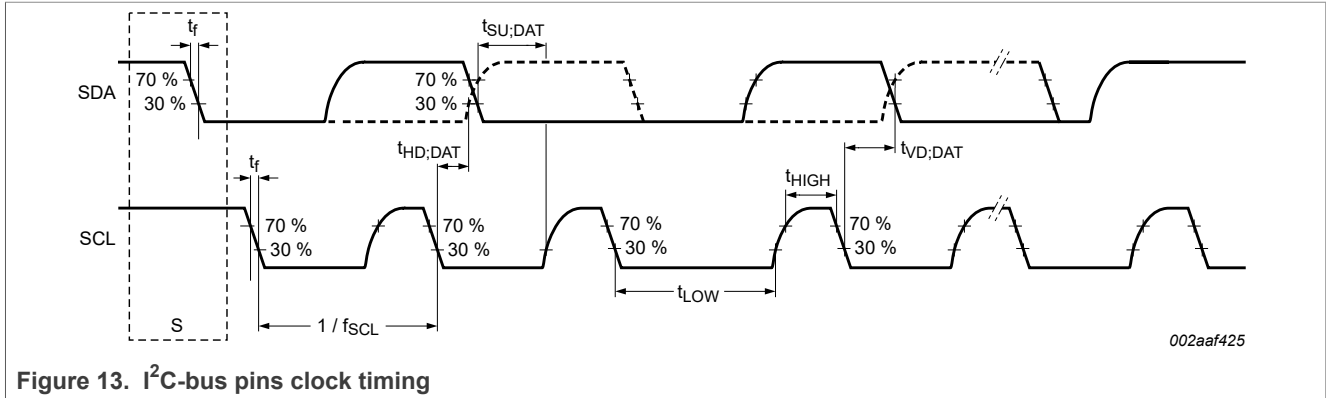


Figure 13. I²C-bus pins clock timing

11.3 SPI interfaces

Table 23. Dynamic characteristics of SPI pins in SPI mode

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------|------------------------|---|--|-----|------------------------------|------|
| SPI leader | | | | | | |
| $t_{cy(clk)}$ | clock cycle time | full-duplex mode | [1] 50 | - | - | ns |
| | | when only transmitting | [1] 40 | - | - | ns |
| $t_{SU;DAT}$ | data setup time | $2.4\text{ V} \leq V_{DD} < 3.6\text{ V}$ | [2] 15 | - | - | ns |
| | | $2.0\text{ V} \leq V_{DD} < 2.4\text{ V}$ | [2] 20 | - | - | ns |
| | | $1.8\text{ V} \leq V_{DD} < 2.0\text{ V}$ | [2] 24 | - | - | ns |
| $t_{HD;DAT}$ | data hold time | | [2] 0 | - | - | ns |
| $t_{v(Q)}$ | data output valid time | | [2] - | - | 10 | ns |
| $t_{h(Q)}$ | data output hold time | | [2] 0 | - | - | ns |
| SPI slave | | | | | | |
| $T_{cy(PCLK)}$ | PCLK cycle time | | [3] 0 [4] | - | - | ns |
| $t_{HD;DAT}$ | data hold time | | [3] $3 \times T_{cy(PCLK)} + 4$ [4] | - | - | ns |
| $t_{v(Q)}$ | data output valid time | | [3] - [4] | - | $3 \times T_{cy(PCLK)} + 11$ | ns |
| $t_{h(Q)}$ | data output hold time | | [3] - [4] | - | $2 \times T_{cy(PCLK)} + 5$ | ns |

[1] $t_{cy(clk)} = (SSPCLKDIV \times (1 + SCR) \times CPDVSUR) / f_{main}$. The clock cycle time derived from the SPI bit rate $t_{cy(clk)}$ is a function of:

- The main clock frequency f_{main}
- The SPI peripheral clock divider (SSPCLKDIV)
- The SPI SCR parameter (specified in the SSP0CR0 register)
- The SPI CPDVSUR parameter (specified in the SPI clock prescale register)

[2] $T_{amb} = -40\text{ }^\circ\text{C}$ to $+105\text{ }^\circ\text{C}$

[3] $t_{cy(clk)} = 12 \times T_{cy(PCLK)}$

[4] $T_{amb} = 25\text{ }^\circ\text{C}$ for normal voltage supply: $V_{DD} = 3.3\text{ V}$

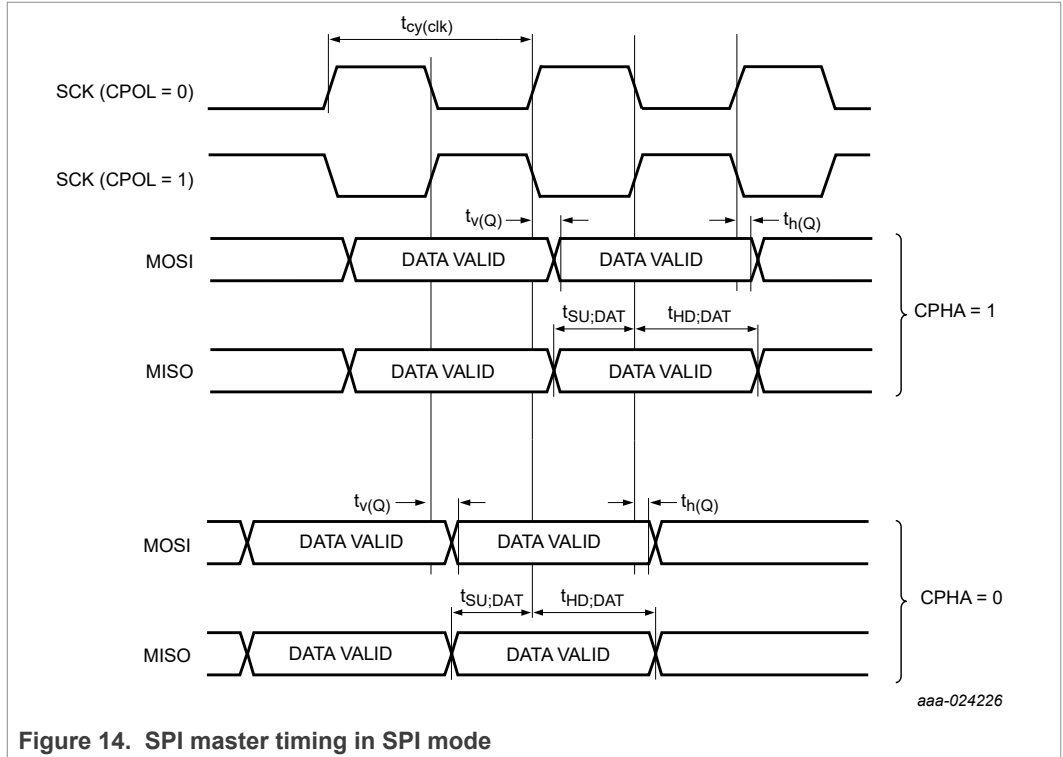


Figure 14. SPI master timing in SPI mode

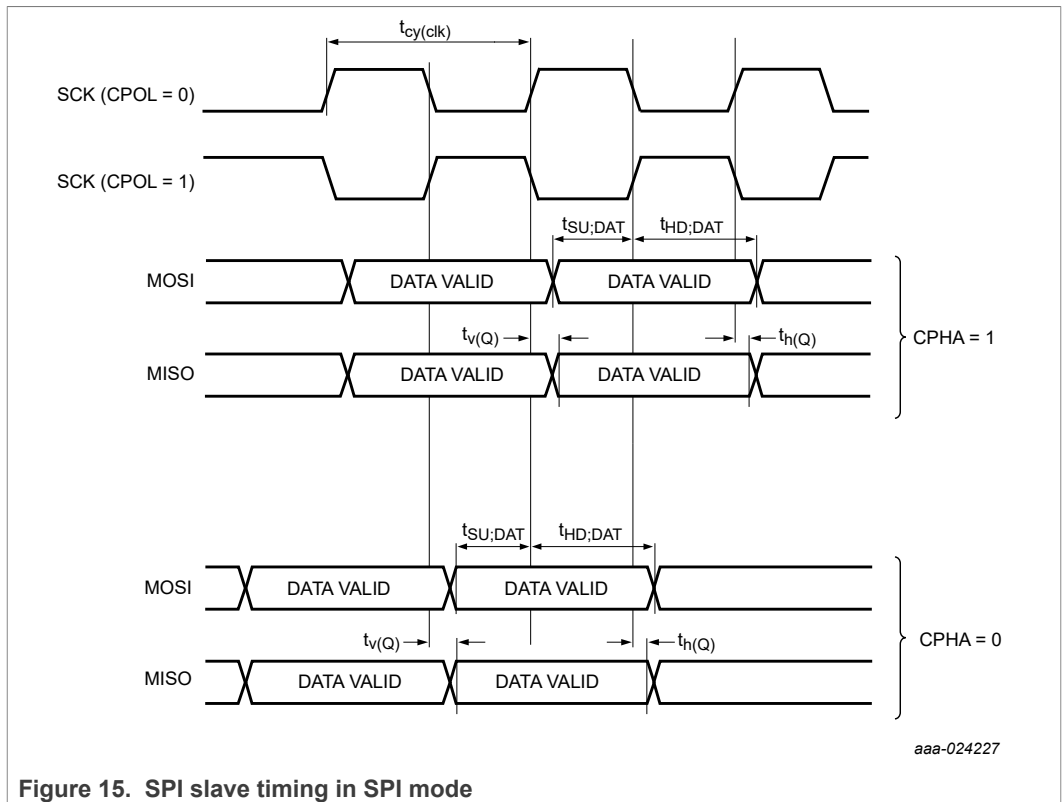


Figure 15. SPI slave timing in SPI mode

12 Package outline

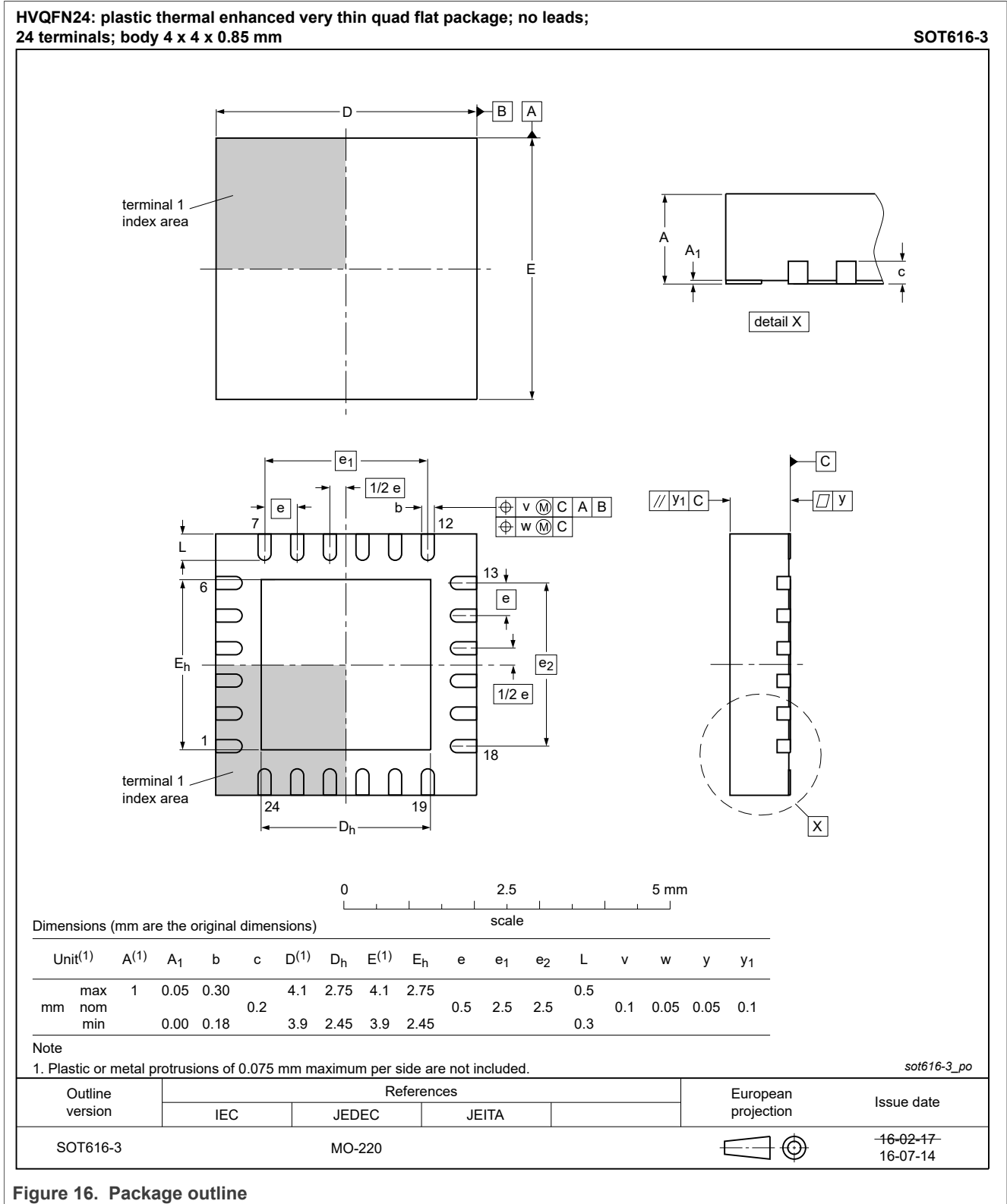


Figure 16. Package outline

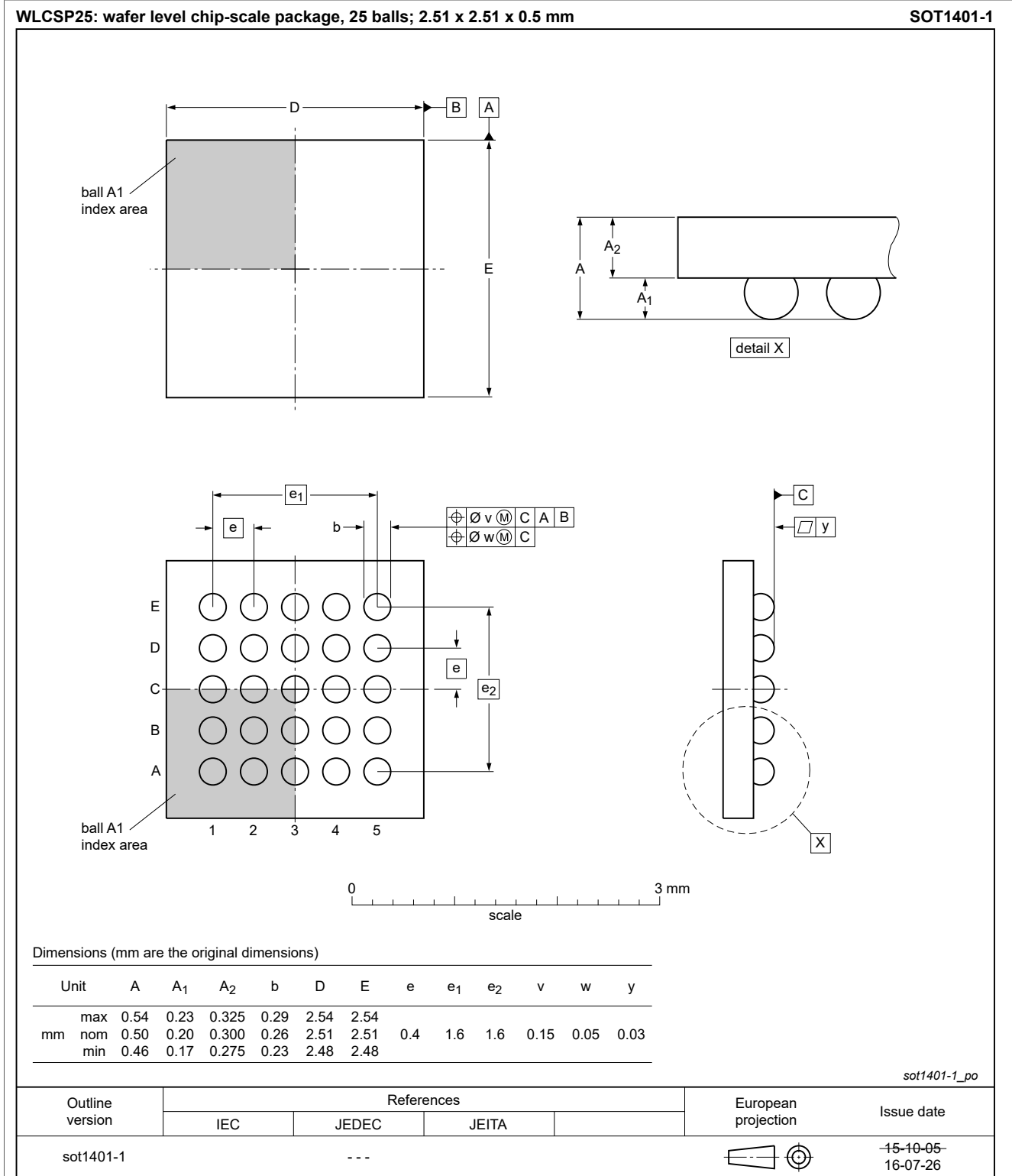


Figure 17. WLCSP25 package outline

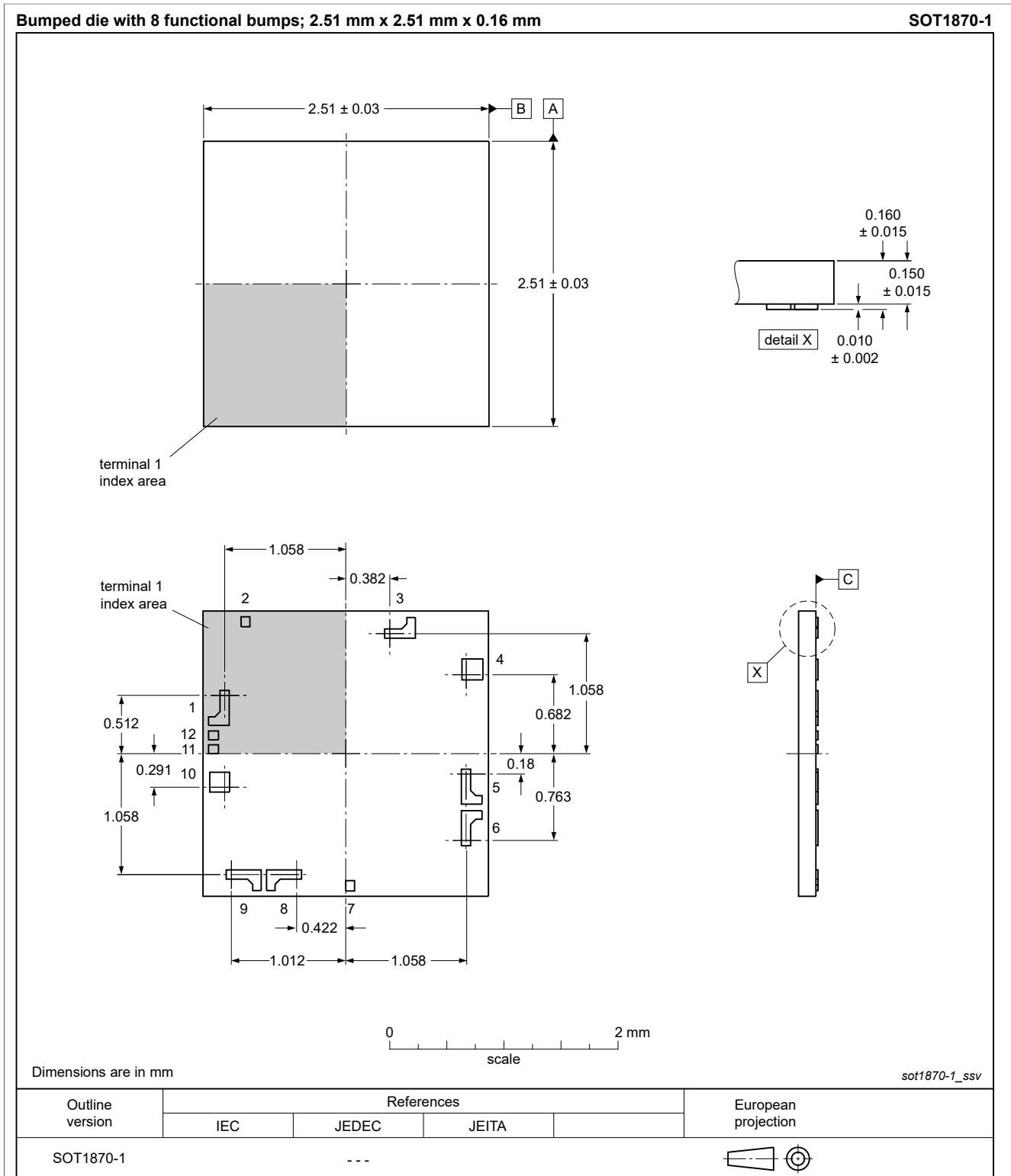


Figure 18. Bumped die package outline

13 Abbreviations

Table 24. Abbreviations

| Acronym | Description |
|---------|---|
| ADC | analog-to-digital converter |
| AHB | advanced high-performance bus |
| AMBA | advanced microcontroller bus architecture |
| APB | advanced peripheral bus |
| API | application programming interface |
| ARM | advanced RISC machine |
| BOD | brownout detection |
| CGU | clock generator unit |
| EEPROM | electrically erasable programmable read-only memory |
| GPIO | general-purpose input output |
| LDO | low drop out |
| MISO | master input slave output |
| MOSI | master output slave input |
| NDEF | NFC data exchange format |
| NFC | near field communication |
| NVIC | nested vectored interrupt controller |
| PMU | power management unit |
| POR | power-on reset |
| PWM | pulse width modulation |
| RFID | radio frequency identification |
| RISC | reduced instruction set computer |
| RTC | real-time clock |
| SFRO | system free-running oscillator |
| SPI | serial peripheral interface |
| SSI | synchronous serial interface |
| SSP | synchronous serial port |
| SR | status register |
| SWD | serial wire debug |
| TFRO | timer free-running oscillator |
| WDT | watchdog timer |

14 References

- | | | |
|-----|--------------------------------------|---|
| [1] | DDI0484C_cortex_m0p_r0p1_trm | Cortex-M0+ Devices - Technical Reference Manual |
| [2] | DUI0662B_cortex_m0p_r0p1_dgug | Cortex-M0+ Devices - Generic User Guide |
| [3] | UM10204 user manual | I ² C-bus specification and user manual; 2014, NXP Semiconductors |

15 Revision history

Table 25. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------|---|------------------------|---------------|-------------|
| NHS3100 v.8 | 20210525 | Product data sheet | - | NHS3100 v.7 |
| Modifications: | <ul style="list-style-type: none"> • Table 18 in Section 10 "Sensor characteristics" updated • Text has been updated throughout the document | | | |
| NHS3100 v.7 | 20190411 | Product data sheet | - | NHS3100 v.6 |
| Modifications: | <ul style="list-style-type: none"> • Section 7 "Pinning" updated • Text has been updated throughout the document | | | |
| NHS3100 v.6 | 20180615 | Product data sheet | - | NHS3100 v.5 |
| Modifications: | <ul style="list-style-type: none"> • NFC certification and logo have been added • Text has been updated throughout the document | | | |
| NHS3100 v.5 | 20161205 | Product data sheet | - | NHS3100 v.4 |
| Modifications | <ul style="list-style-type: none"> • Addition of NHS3100W8 package data | | | |
| NHS3100 v.4 | 20160905 | Product data sheet | - | NHS3100 v.3 |
| Modifications | <ul style="list-style-type: none"> • General update • Section 10 "Static characteristics" updated • Drawing revisions | | | |
| NHS3100 v.3 | 20160601 | Preliminary data sheet | - | NHS3100 v.2 |
| Modifications | <ul style="list-style-type: none"> • General update | | | |
| NHS3100 v.2 | 20160531 | Objective data sheet | - | NHS3100 v.1 |
| Modifications | <ul style="list-style-type: none"> • Section 7 "Pinning" updated • Section 8.4.2 "Power Management Unit (PMU)" major revision • Section 11.2 "I²C-bus" updated • Section 11.3 "SPI interfaces" added • Section 12: WLCSP25 package added • Section 1: Cautions added • Section 10 "Static characteristics" updated • Section 8.7 "Fast General-Purpose parallel I/O" added | | | |
| NHS3100 v.1 | 20150811 | Objective data sheet | - | - |

16 Legal information

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|-----------------------------------|-------------------------------|---|
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| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Contents

| | | | | | |
|----------|---|-----------|-----------|--------------------------------|-----------|
| 1 | General description | 1 | 8.12.2 | General description | 26 |
| 2 | Features and benefits | 2 | 8.13 | Watchdog timer (WDT) | 26 |
| 2.1 | System | 2 | 8.13.1 | Features | 26 |
| 2.2 | Memory | 2 | 8.13.2 | General description | 27 |
| 2.3 | Digital peripherals | 2 | 8.14 | System tick timer | 27 |
| 2.4 | Analog peripherals | 2 | 8.14.1 | Features | 27 |
| 2.5 | Communication interfaces | 2 | 8.14.2 | General description | 27 |
| 2.6 | Clock generation | 2 | 8.15 | Real-time clock (RTC) timer | 27 |
| 2.7 | Power control | 2 | 8.15.1 | Features | 27 |
| 2.8 | General | 3 | 8.15.2 | General description | 27 |
| 3 | Applications | 3 | 8.16 | Temperature sensor | 28 |
| 4 | Ordering information | 3 | 8.16.1 | Features | 28 |
| 5 | Marking | 3 | 8.16.2 | General description | 28 |
| 6 | Block diagram | 4 | 8.17 | Serial wire debug (SWD) | 28 |
| 7 | Pinning | 5 | 8.18 | On-chip flash memory | 29 |
| 7.1 | HVQFN24 | 5 | 8.18.1 | Reading from flash | 29 |
| 7.2 | WLCSP25 | 7 | 8.18.2 | Writing to flash | 29 |
| 7.3 | NHS3100W8 | 9 | 8.18.3 | Erasing/programming flash | 29 |
| 8 | Functional description | 11 | 8.19 | On-chip SRAM | 29 |
| 8.1 | Arm Cortex-M0+ core | 11 | 8.20 | On-chip EEPROM | 29 |
| 8.2 | Memory map | 11 | 8.20.1 | Reading from EEPROM | 29 |
| 8.3 | System configuration | 12 | 8.20.2 | Writing to EEPROM | 30 |
| 8.3.1 | Clock generation | 12 | 9 | Limiting values | 31 |
| 8.3.2 | Reset | 13 | 10 | Static characteristics | 32 |
| 8.4 | Power management | 13 | 11 | Dynamic characteristics | 35 |
| 8.4.1 | System power architecture | 14 | 11.1 | I/O pins | 35 |
| 8.4.2 | Power management unit (PMU) | 17 | 11.2 | I2C-bus | 35 |
| 8.5 | Nested vectored interrupt controller (NVIC) | 18 | 11.3 | SPI interfaces | 36 |
| 8.5.1 | Features | 18 | 12 | Package outline | 38 |
| 8.5.2 | Interrupt sources | 18 | 13 | Abbreviations | 41 |
| 8.6 | I/O configuration | 19 | 14 | References | 42 |
| 8.6.1 | PIO0 pin mode | 19 | 15 | Revision history | 43 |
| 8.6.2 | PIO0 I2C-bus mode | 19 | 16 | Legal information | 44 |
| 8.6.3 | PIO0 current source mode | 19 | | | |
| 8.7 | Fast general-purpose parallel I/O | 20 | | | |
| 8.7.1 | Features | 20 | | | |
| 8.8 | I2C-bus controller | 21 | | | |
| 8.8.1 | Features | 21 | | | |
| 8.8.2 | General description | 21 | | | |
| 8.8.3 | I2C-bus pin description | 22 | | | |
| 8.9 | SPI controller | 22 | | | |
| 8.9.1 | Features | 22 | | | |
| 8.9.2 | General description | 22 | | | |
| 8.9.3 | Pin description | 22 | | | |
| 8.9.3.1 | Pin detailed description | 22 | | | |
| 8.10 | RFID/NFC communication unit | 24 | | | |
| 8.10.1 | Features | 24 | | | |
| 8.10.2 | General description | 24 | | | |
| 8.11 | 16-bit timer | 25 | | | |
| 8.11.1 | Features | 25 | | | |
| 8.11.2 | General description | 25 | | | |
| 8.12 | 32-bit timer | 26 | | | |
| 8.12.1 | Features | 26 | | | |

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